

Liquid Metal Embedded Elastomers (LMEEs) as TIM1 with Highly Reliable & Extremely Low Thermal Resistance Performance

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Dr. Navid Kazem



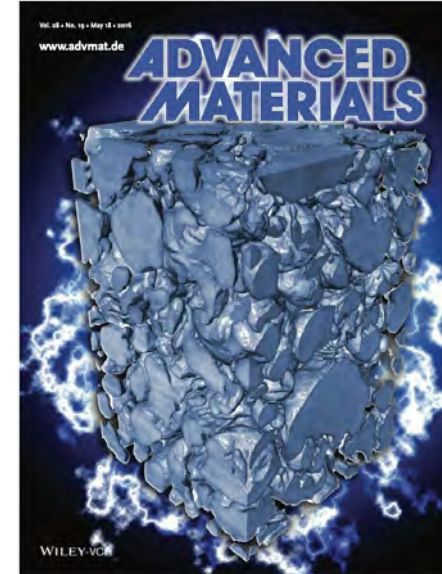
- **Bachelor of Science (2012)**
 - Sharif University



- **Master of Science (2013)**
 - Carnegie Mellon University



- **PhD (2018)**
 - Computational Mechanics, CMU
 - Swartz Entrepreneurship Fellow from Tepper School of Business



- **Co-Founder and CEO at Arieca (2018-Present)**
 - VC backed advanced materials startup
 - Developing modern materials for a connected society

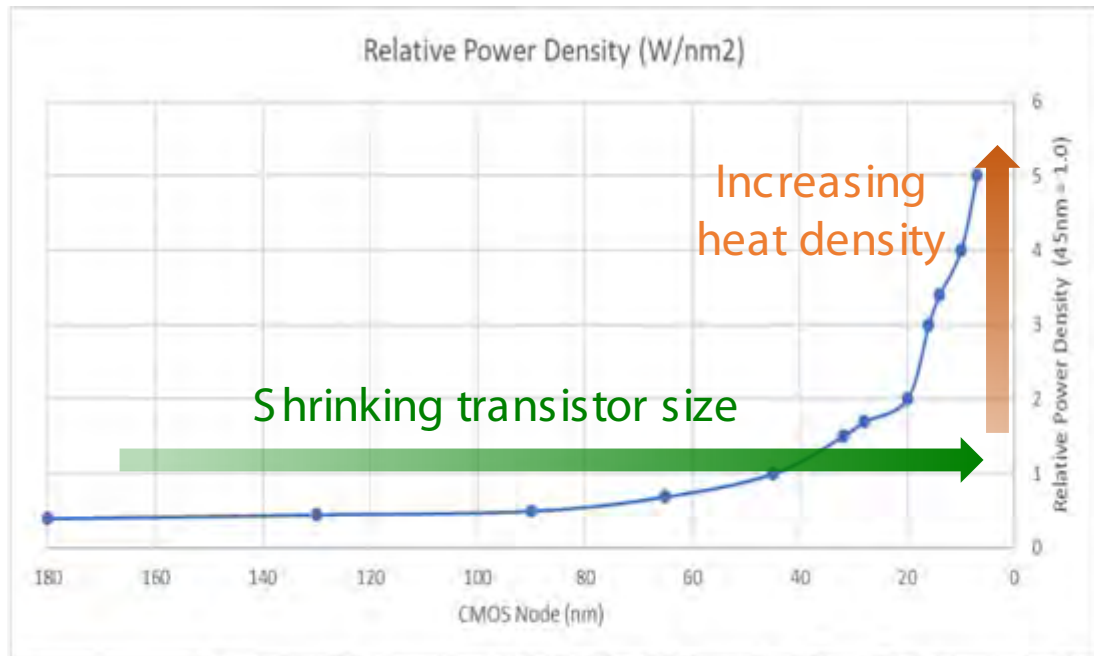




Moore's Law

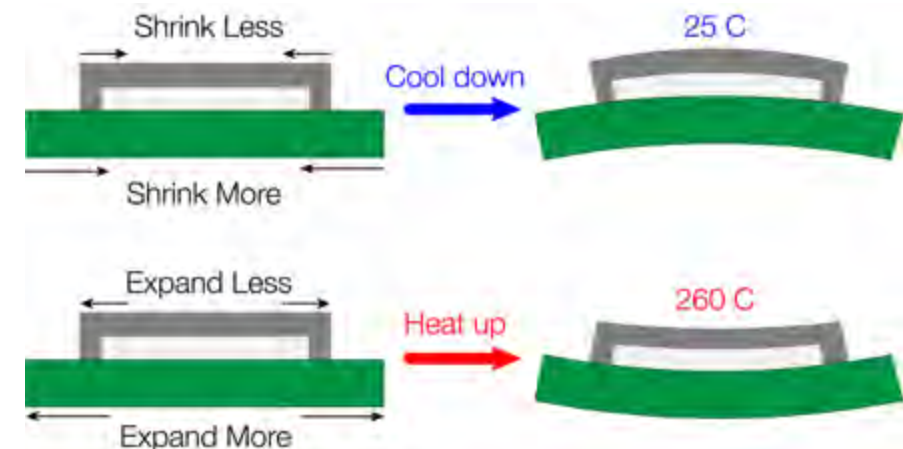
Meets

Physically Constrained Footprints



Source: Stillwater, Bass "Scaling equations for the accurate prediction of CMOS device performance from 180 nm to 7 nm", Integration June 2017

TDP >> 100W for current generation high performance devices





Moore's Law

Meets

Physically Constrained Footprints

Objective: To Develop Thermal Interface Materials (TIM1) with

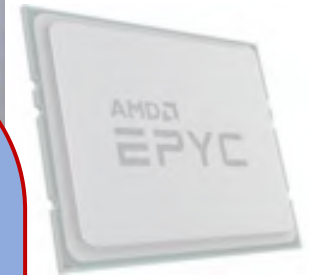
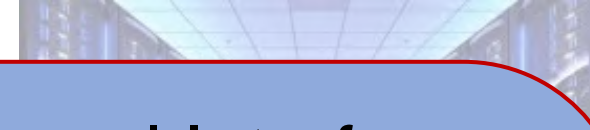
Thermal Resistance
approaching of Liquid
Metals

Mechanical Reliability
Performance of
Polymer-TIMs

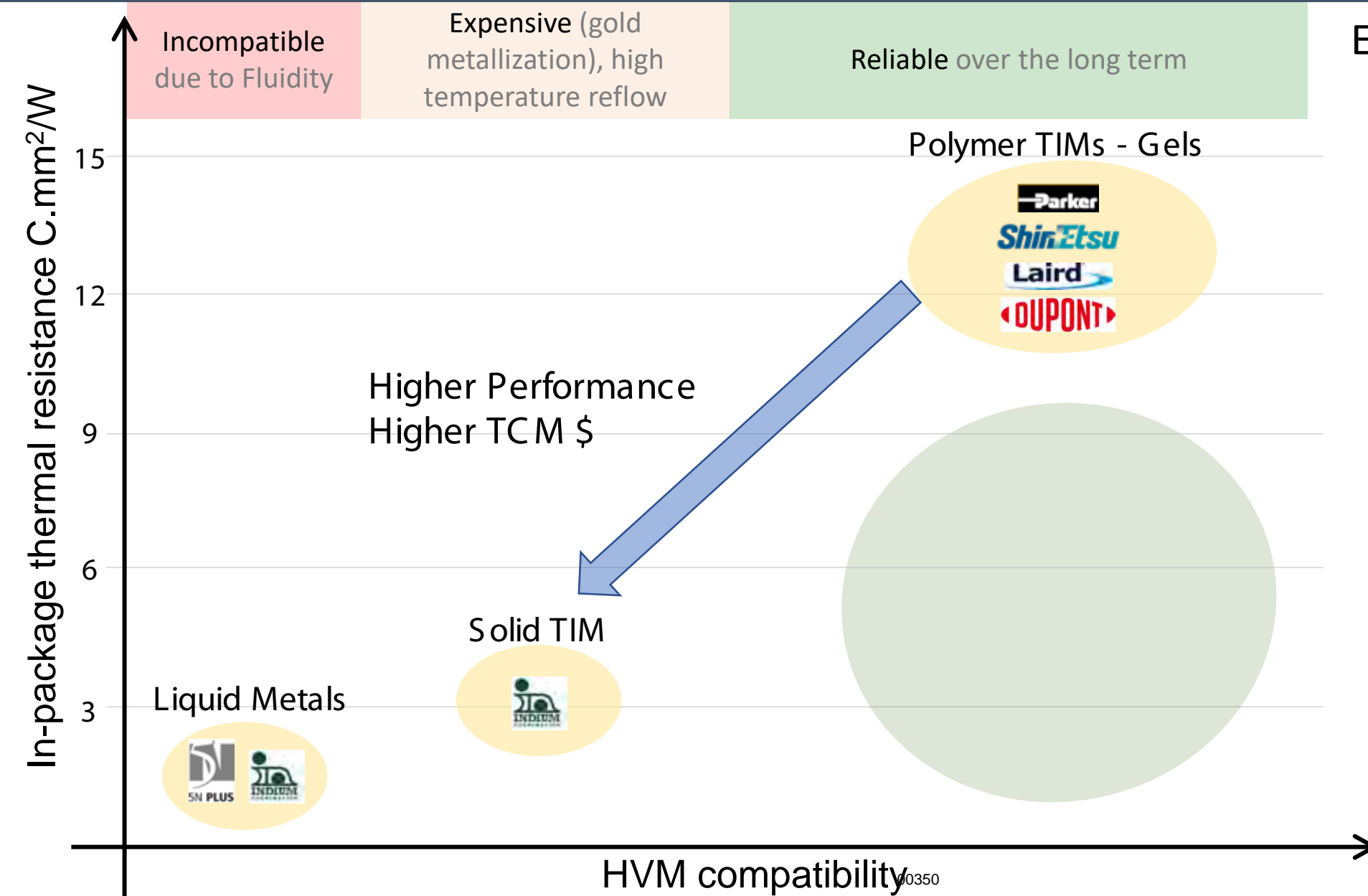
Ease of Semiconductor
Packaging Manufacturing
of Greases



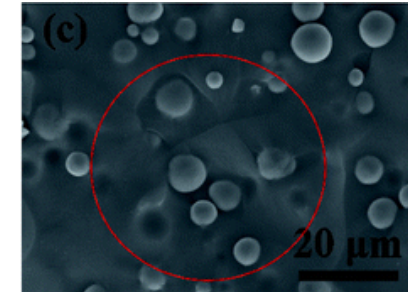
TDP >> 100
high pe



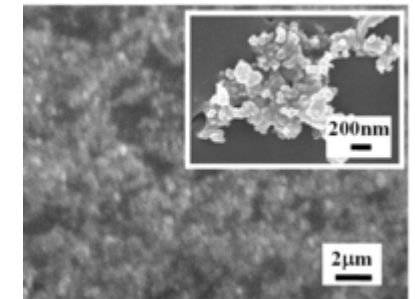
Existing Solutions - Thermal Interface Materials (TIM1)



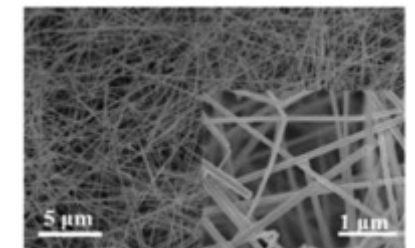
Existing high-performance TIMs have tradeoffs



Aluminum Oxide - Silver



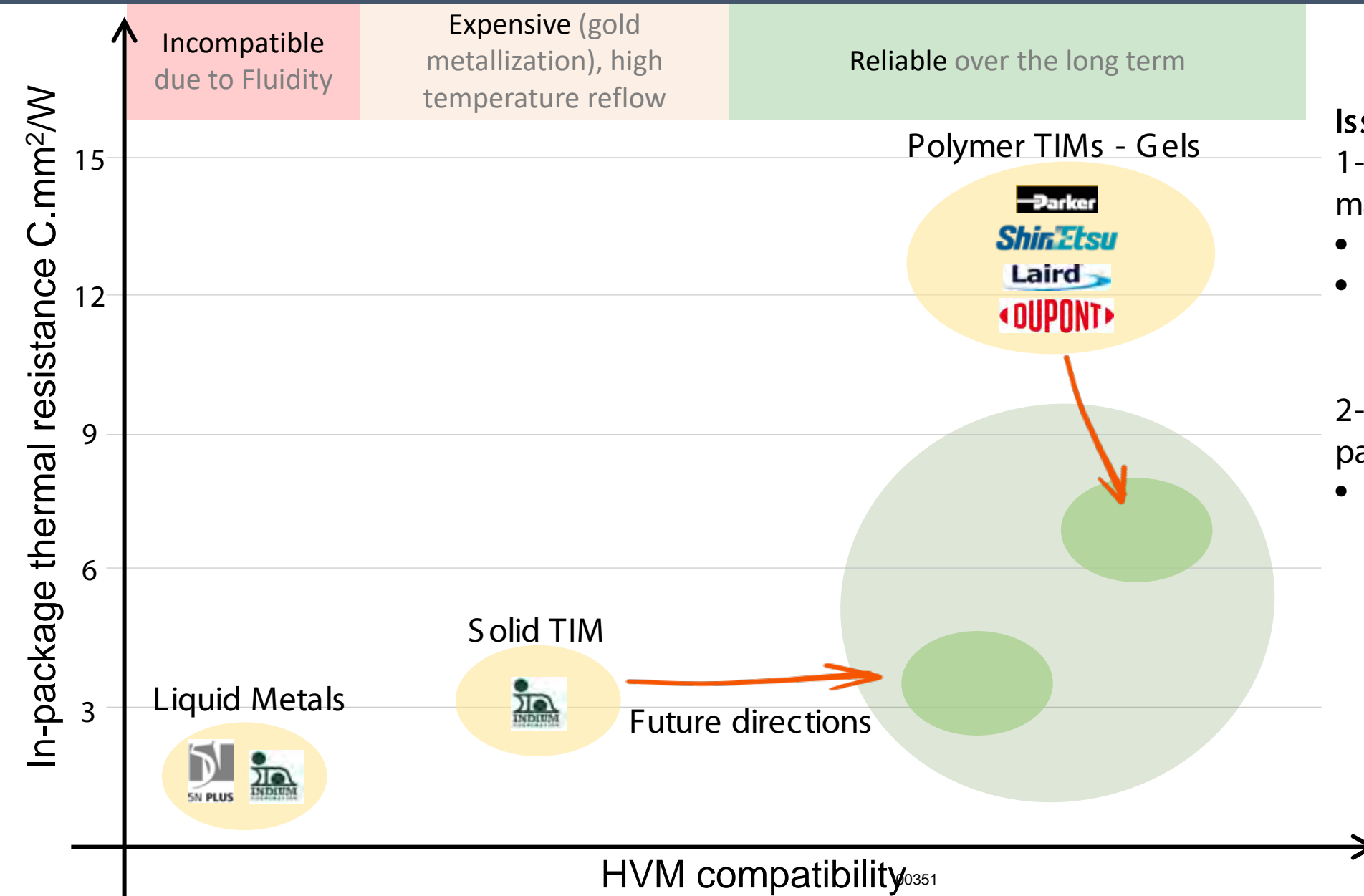
Boron Nitride



Vertically aligned Carbon



Existing Solutions - Thermal Interface Materials (TIM1)



Issues:

1- Reducing the BLT while maintaining Reliability

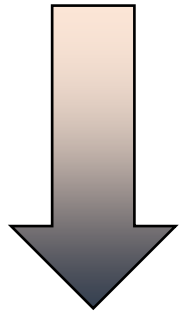
- Pressure requirements
- Thermal Shock

2- Contact resistance between particles

- The struggle of thermal conductivity vs thermal resistance

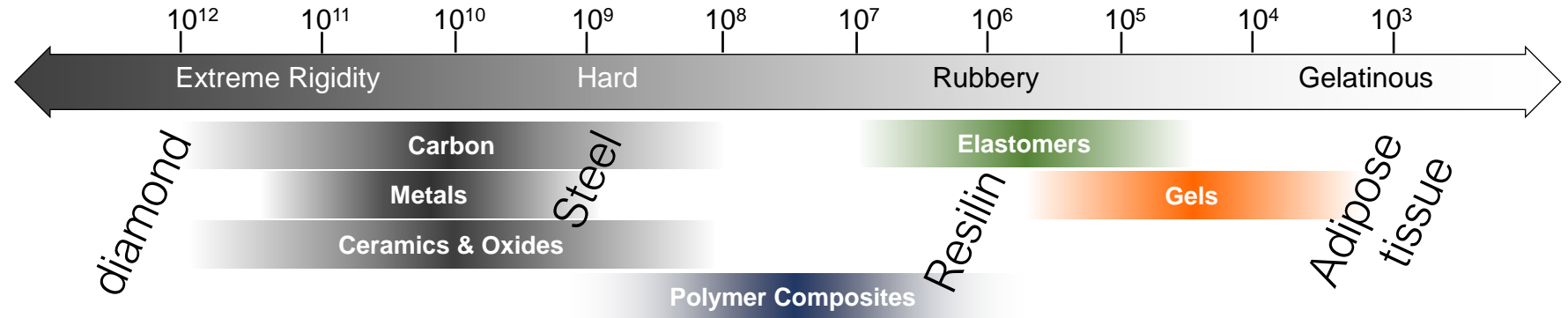


Soft
Materials

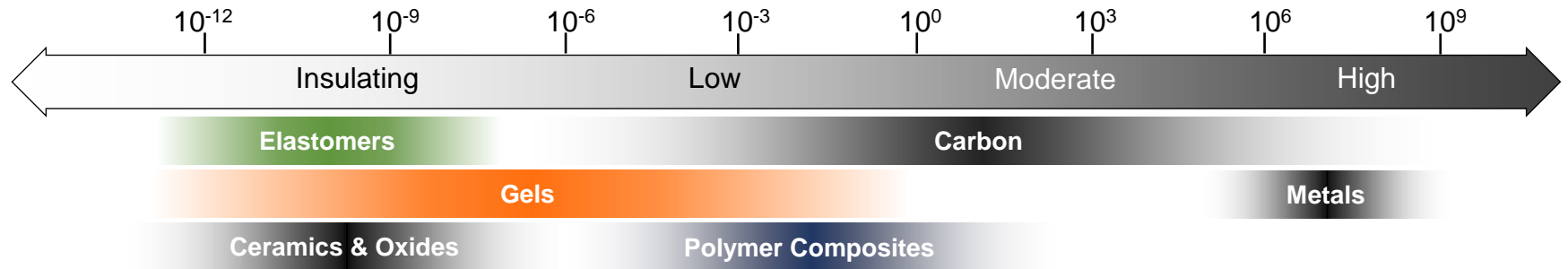


Rigid
Functionality

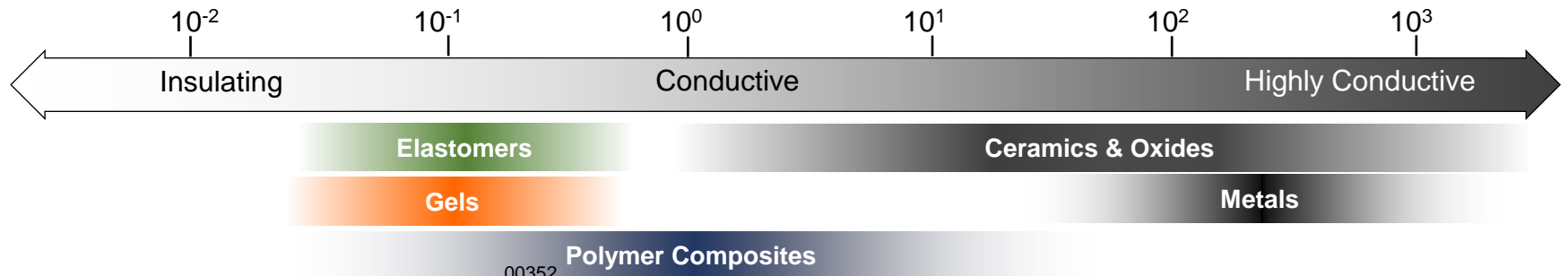
Compliance • Young's Modulus (Pa)



Electrical Conductivity • Volumetric Conductivity (S/m)



Thermal Conductivity • (W/m·K)





Indium Corp.
5N plus



Chiechi et al., Angew. Chemie - Int. Ed. 2008

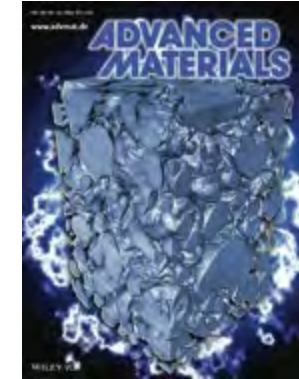
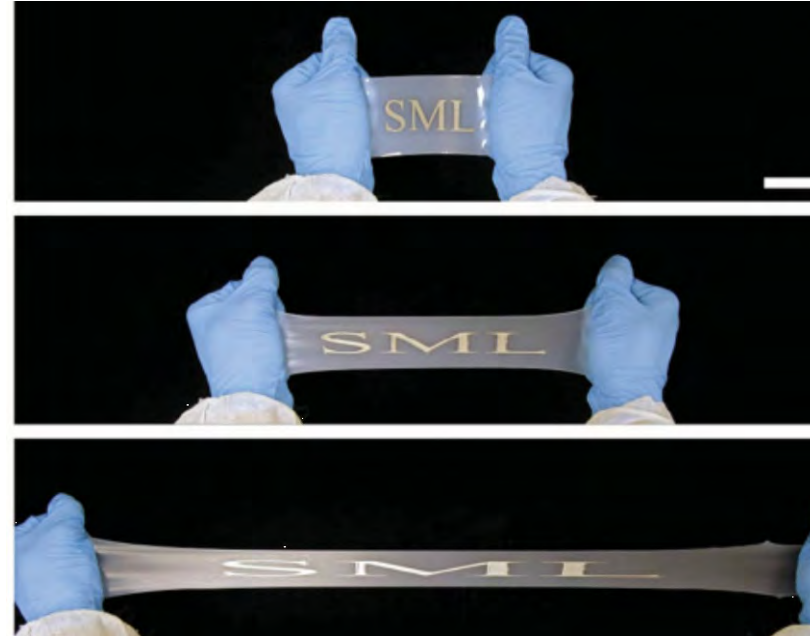
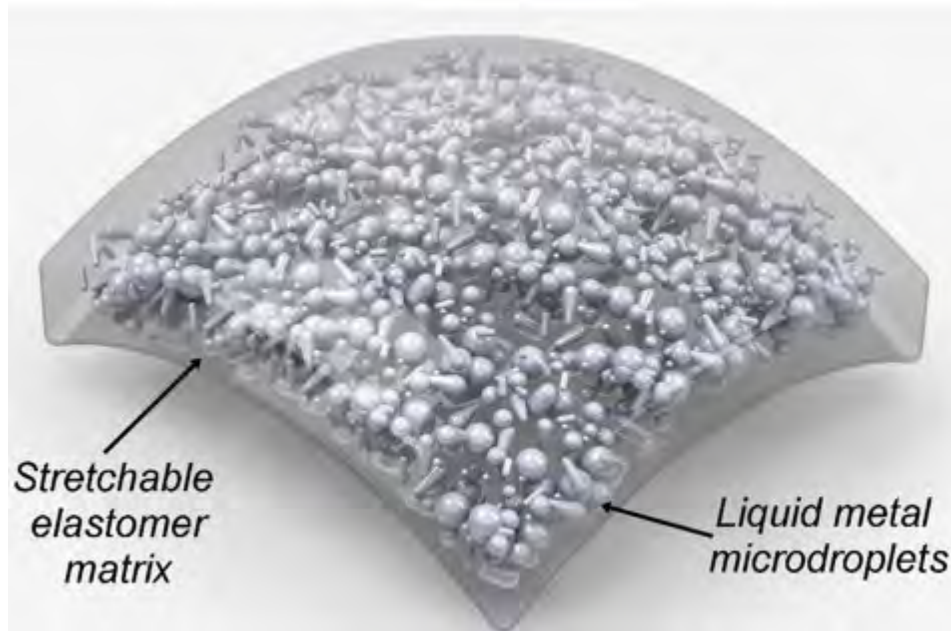


Joshi et al., J. Mater. Chem. C., 2015.

- Eutectic Gallium Indium (74.5% Ga, 24.5% In; by weight)
- Low melting point $\sim 15.5^{\circ}\text{C}$
- Negligible toxicity
- Low viscosity $1.99 \text{ mPa}\cdot\text{s}$
- High electrical and thermal conductivity ($\sigma = 3.4 \times 10^6 \text{ S/m}$, $k = 26.4 \text{ W/m}\cdot\text{K}$, at $\sim 30^{\circ}\text{C}$)

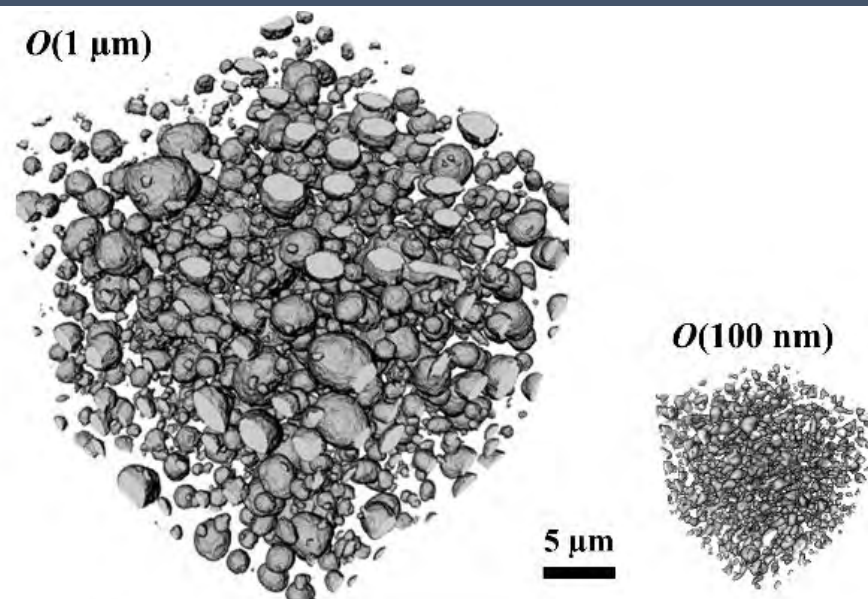
Merging Liquid Metal and Elastomers

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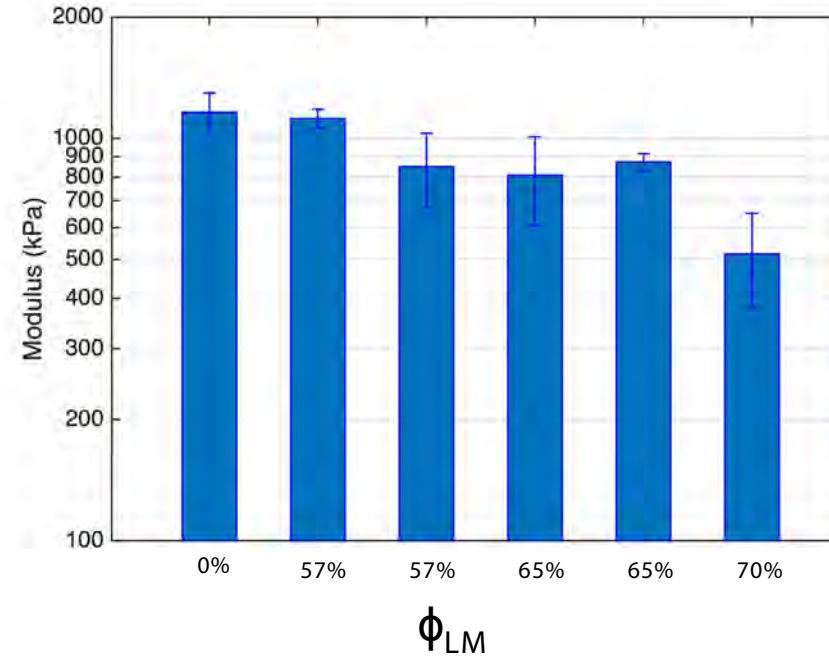
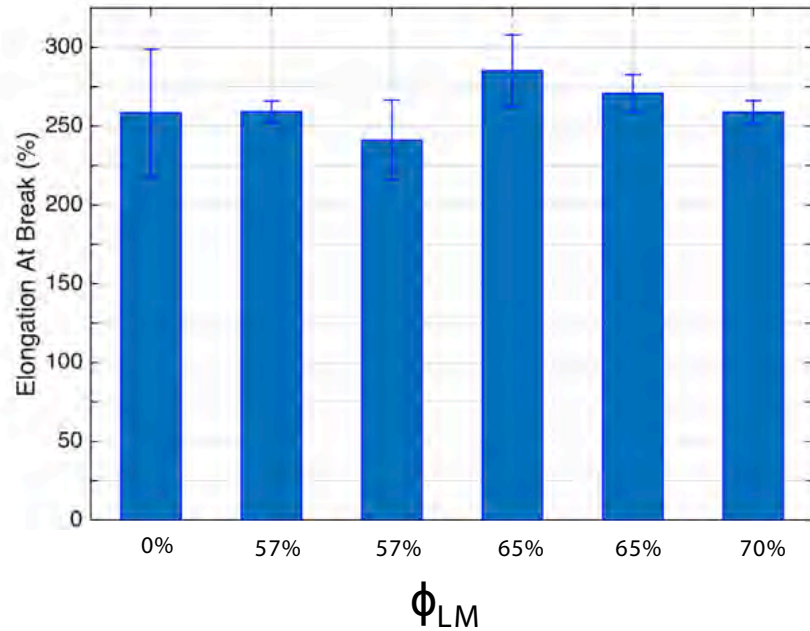
- Breakthrough material architecture that uniquely combines elasticity & printability of rubber with conductivity of metal
- Transforms the way liquid metal can be used in computing and electronics
- Our academic publications on LM-elastomer composites are among the top 0.1% most highly cited papers in materials engineering

Liquid Metal Embedded Elastomers (LMEE) - Microstructure

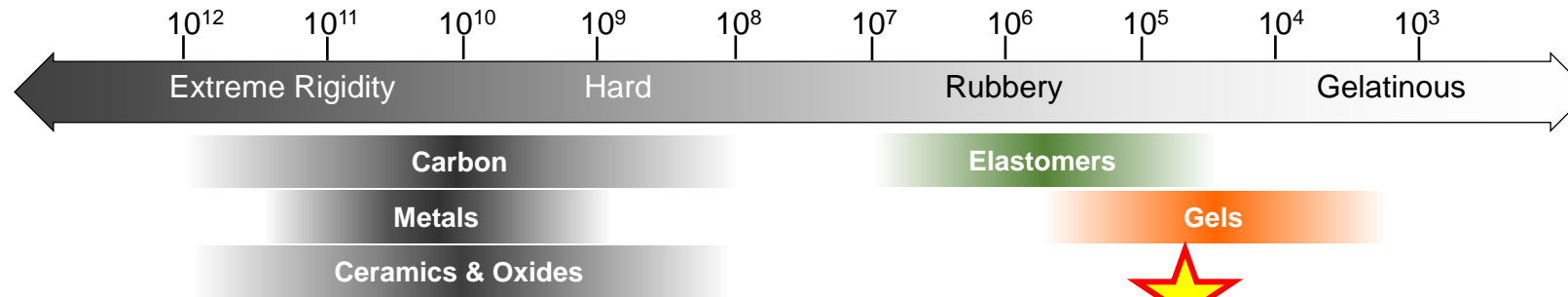




Liquid Metal Embedded Elastomers (LMEE) - Polymer



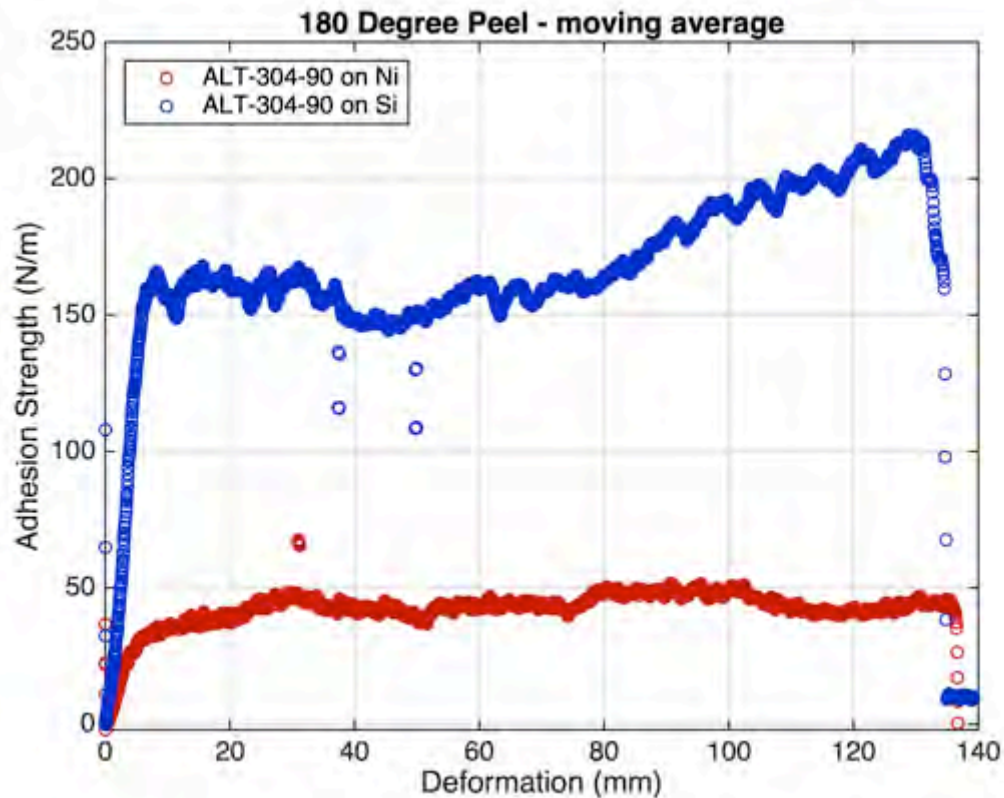
Compliance • Young's Modulus (Pa)





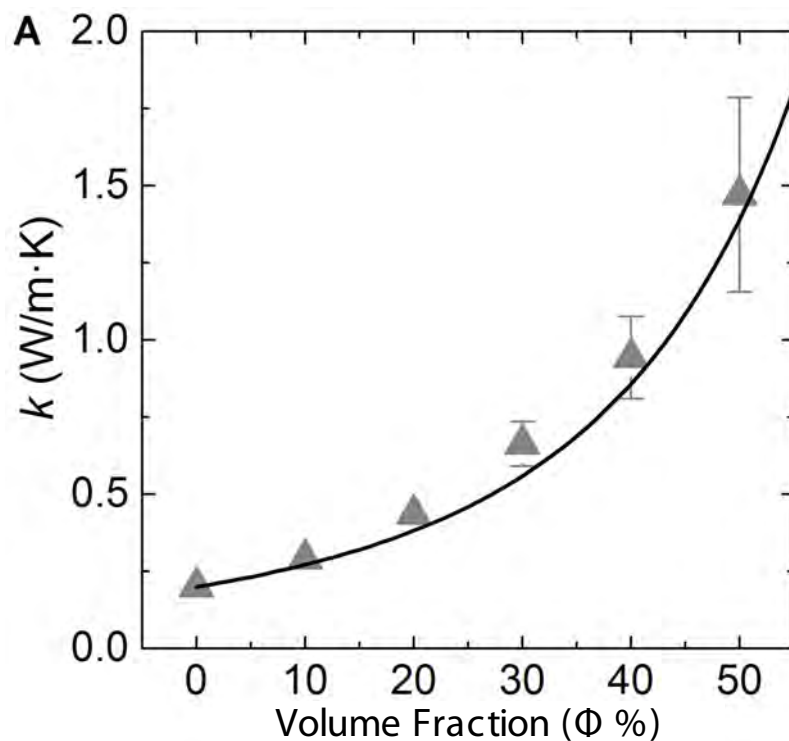
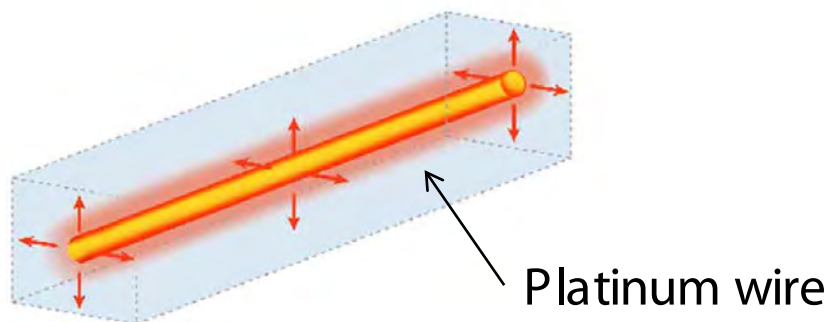
Liquid Metal Embedded Elastomers (LMEs) – Polymer Adhesion

LMEs maintains excellent adhesion to both nickel and silicon even when heavily loaded to provide low thermal resistance



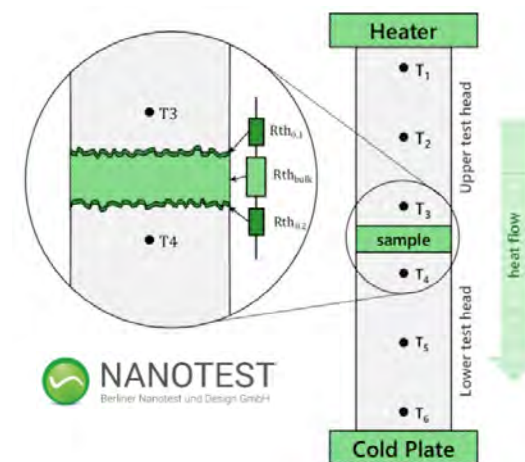


Transient Hot wire Method

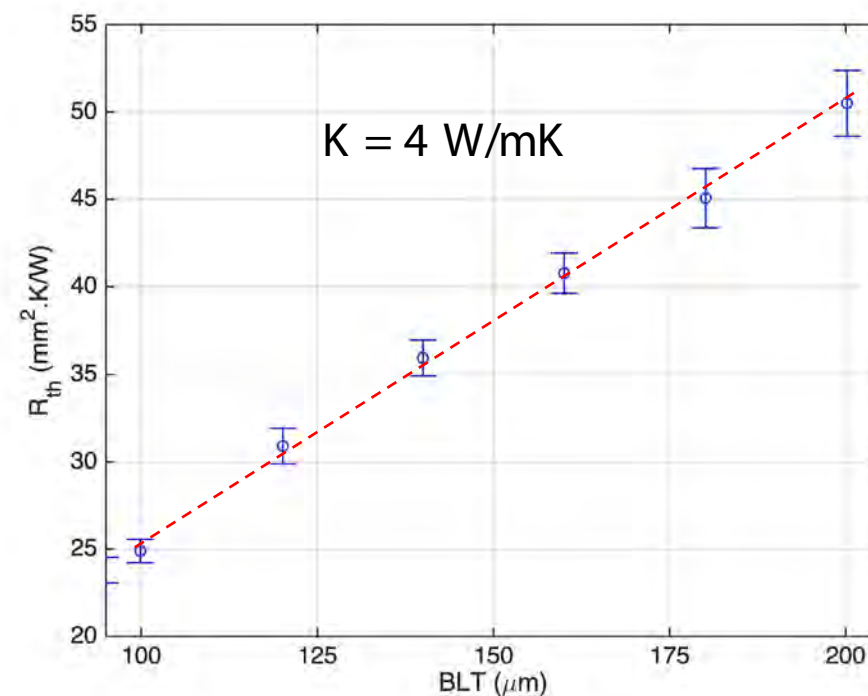


M. D. Bartlett *et al.*, "High thermal conductivity in soft elastomers with elongated liquid metal inclusions," *Proc. Natl. Acad. Sci.*, 2017. 00358

ASTM D5470

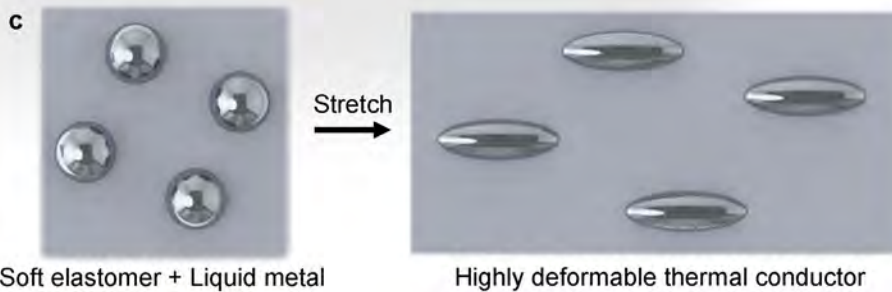
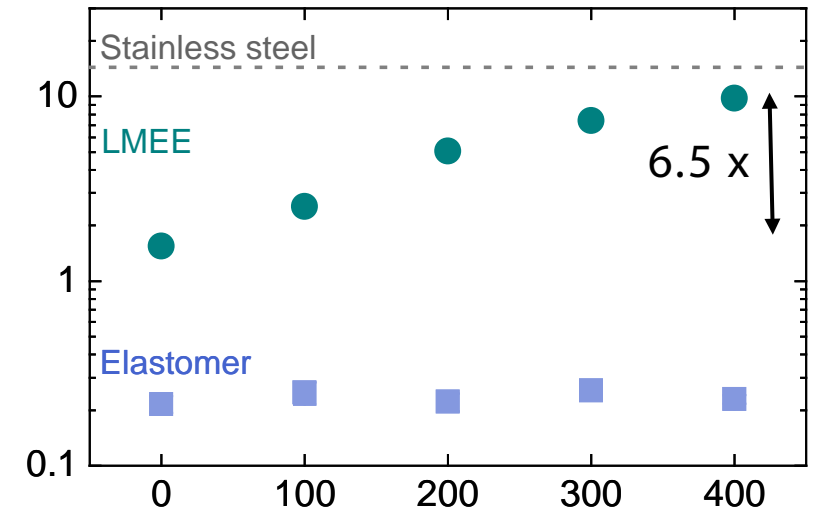
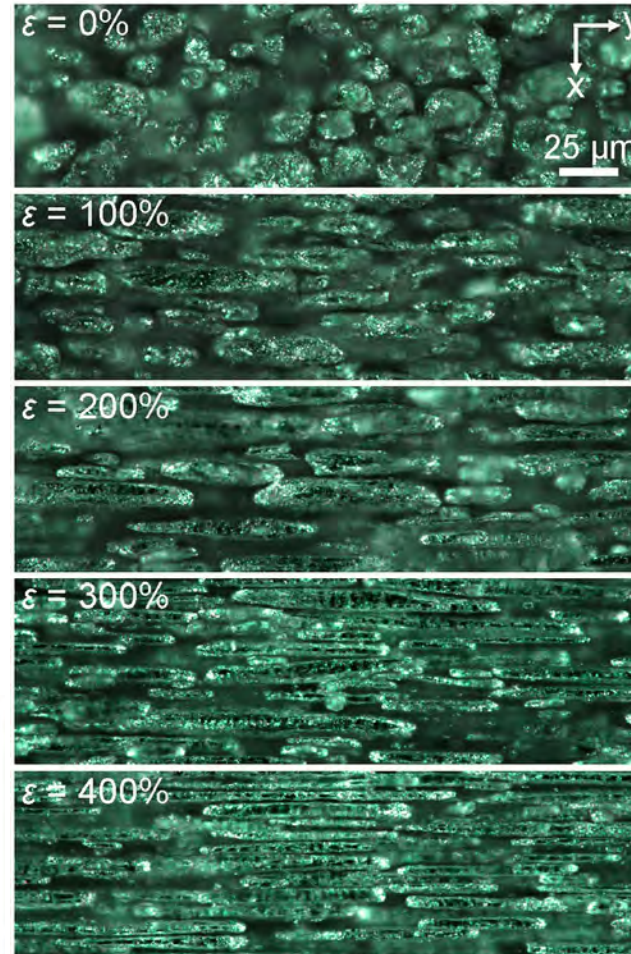
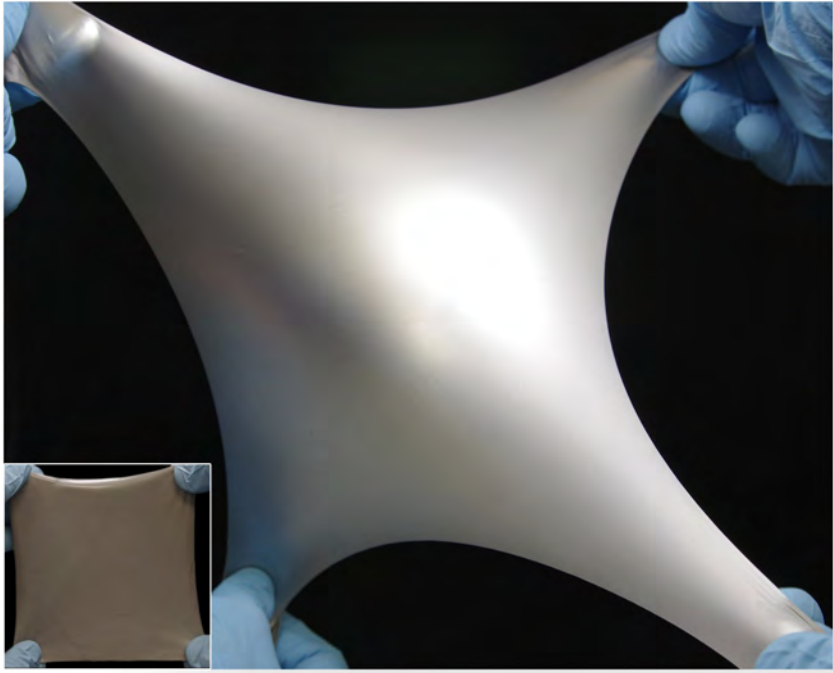


Volume Fraction $\Phi = 65\%$



Thermal Performance Through Extreme Deformability

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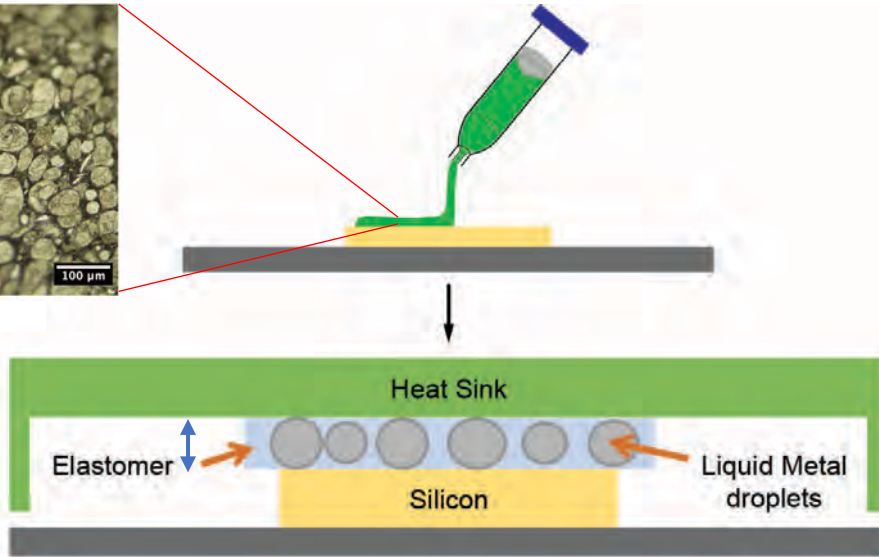
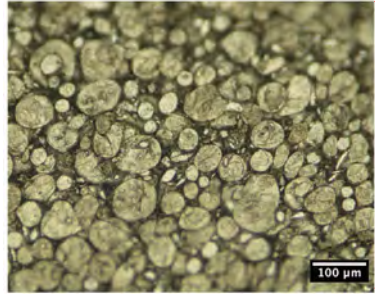


M. D. Bartlett *et al.*, "High thermal conductivity in soft elastomers with elongated liquid metal inclusions," *Proc. Natl. Acad. Sci.*, 2017.

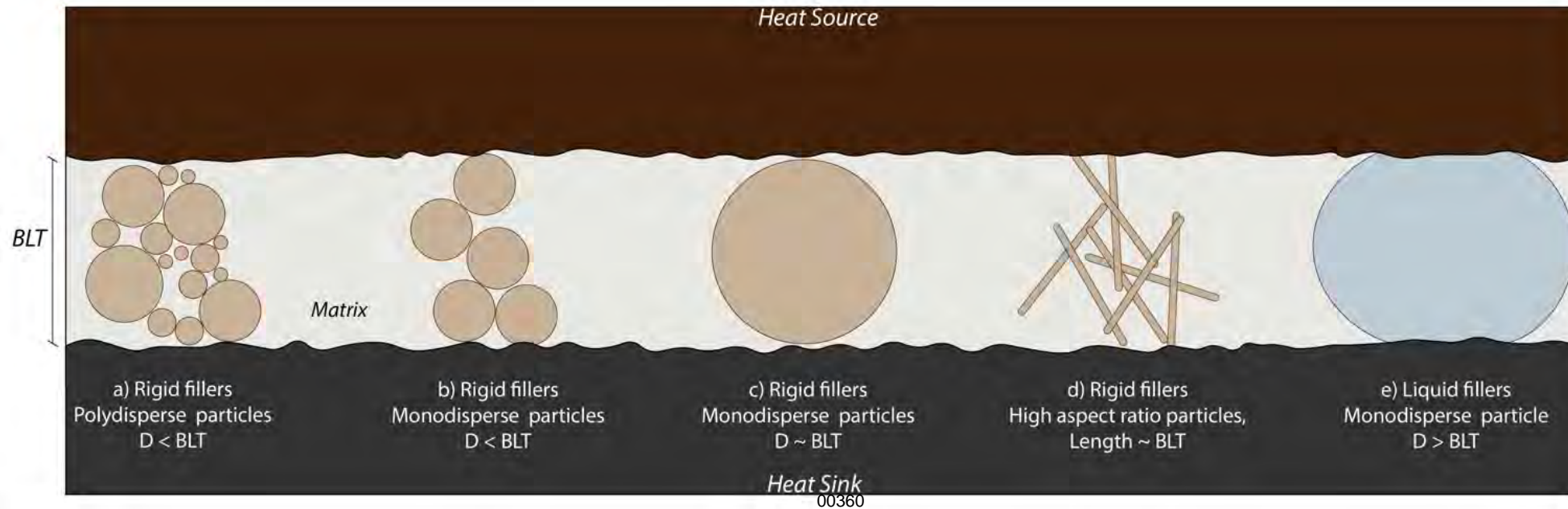
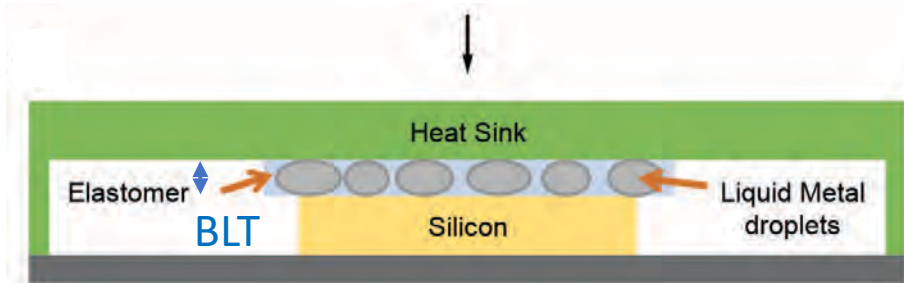
00359

Novel Microstructure for TIM1

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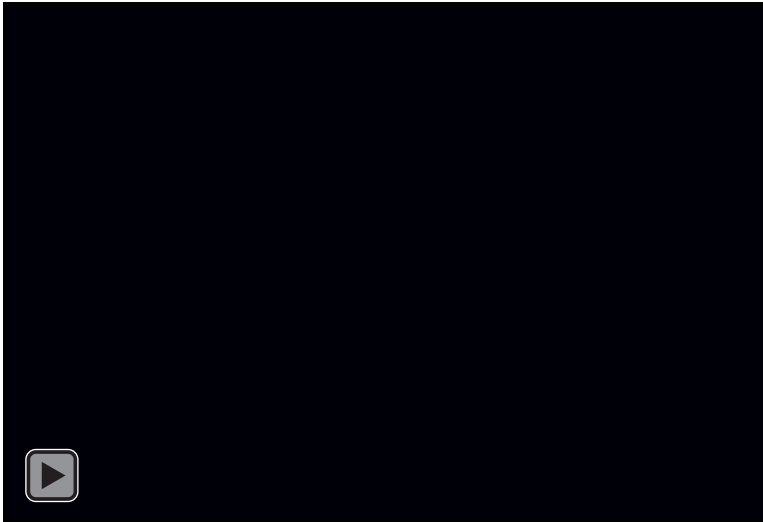


- Bond-Line Thickness < Particle Sizes
- Extremely deformable Liquid Metal fillers
- Increase in contact area
- Decrease in contact resistance





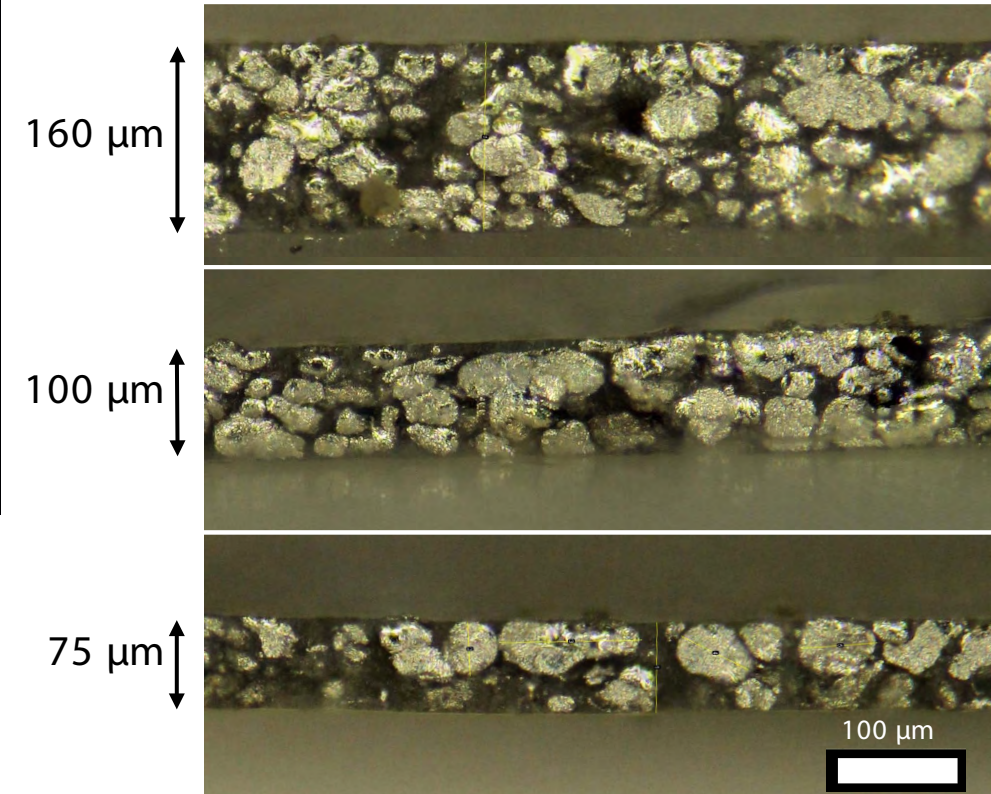
TIM being applied to IC with standard techniques



Clamping video showing deformation in Liquid Metal droplets



Cross Sectional images of Liquid Metal compression while frozen (using liquid nitrogen $< -60^{\circ}\text{C}$)



Thermal Resistance Measurement

» Temperatures

- › Sample $T_{S,avg} \approx 25\text{ °C}$
- › Heater $T_H = 30\text{ °C}$ (set point)
- › Liquid Cold Plate $T_C \approx 15\text{ °C}$

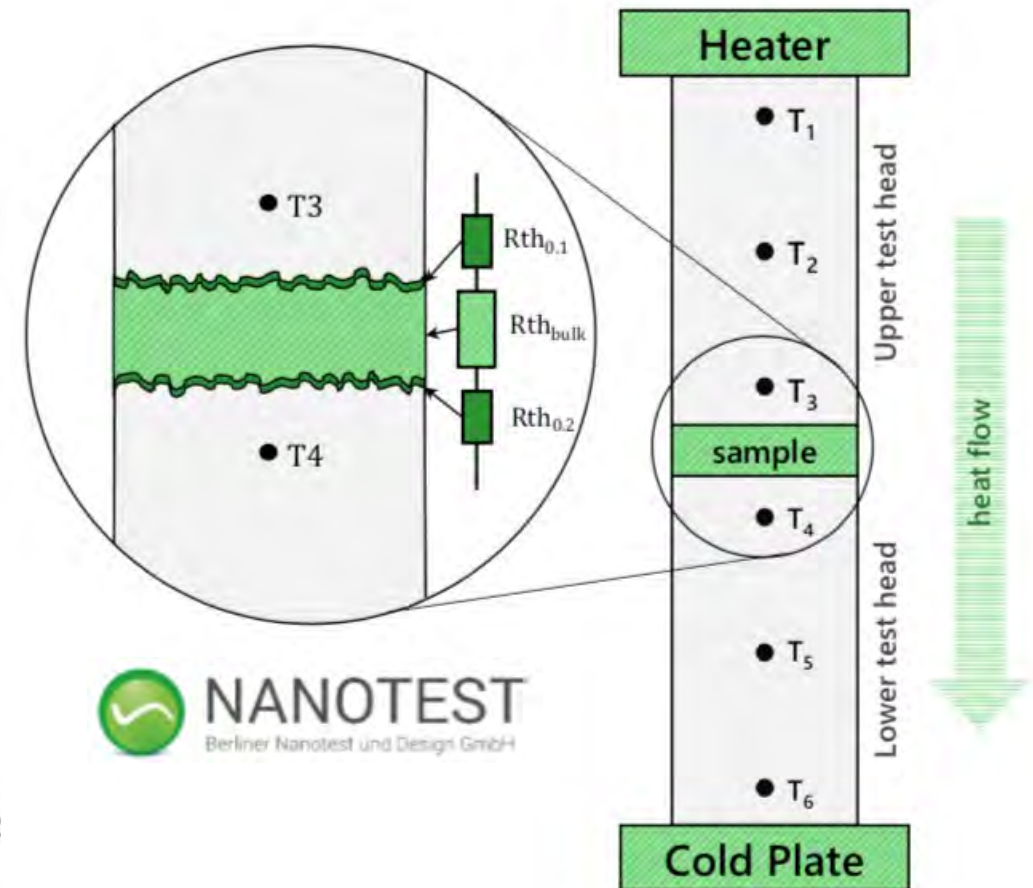
» BLTs

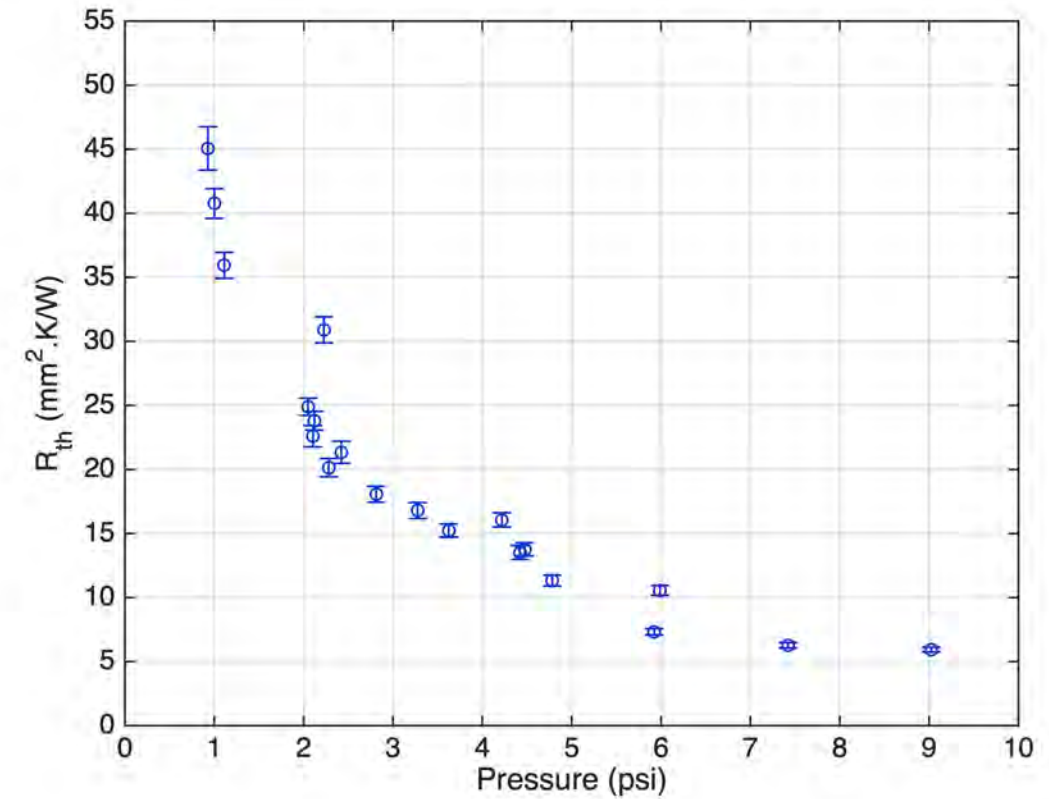
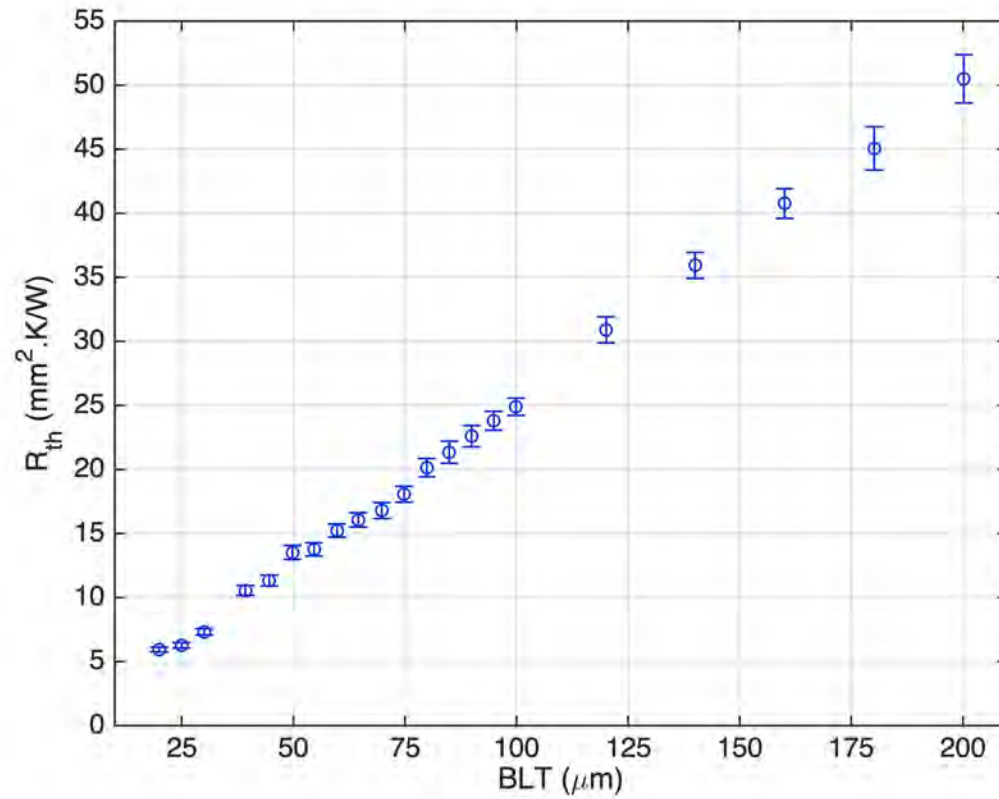
- › BLTs measured:
200, 180, ..., 120, 100,
95, 80, ..., 25, 20 μm

» Contacting surfaces

- › Material: Cu - Cu
- › Roughness $R_z < 2\text{ }\mu\text{m}$
- › Area A : 1.33 cm^2

» Measurement method: ASTM D 5470





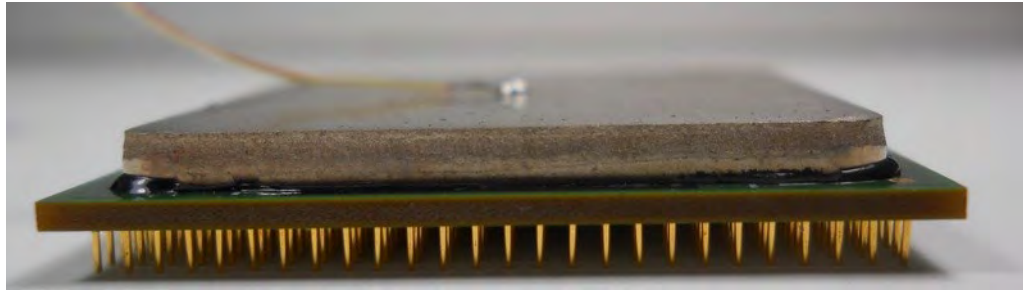
BLT (μm)	R (mm ² .K/W)	P (psi)
20	5.9	9
30	7.3	5.9
40	10.3	4.4



Thermal Test Vehicle

General TTV Characteristics

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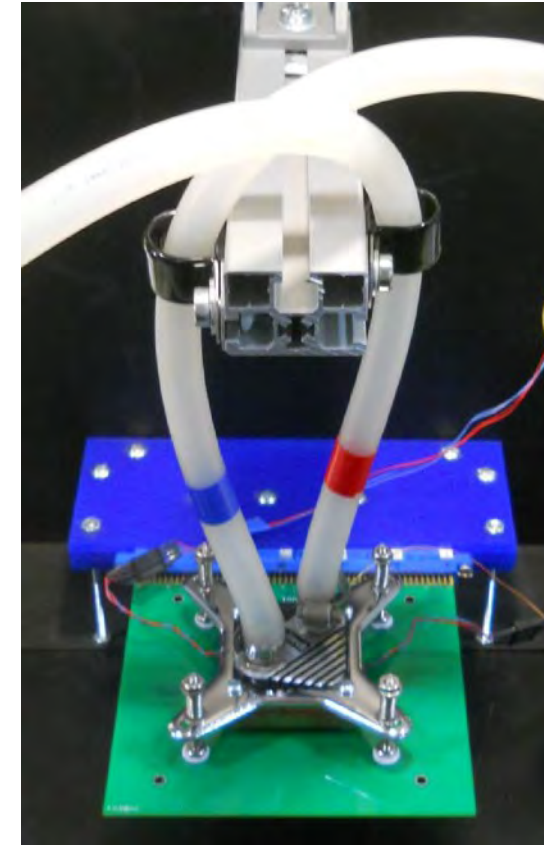
Partner Proprietary TTV (x2)

~11mm x 13mm active die

Integrated heater network and thermal diodes

TIMbber ALT304-90 cure: 1 hr @ 70C, 1 hour ramp to 125C

Lid attach: Dowsil 3-6265, 1hour cure @ 125C



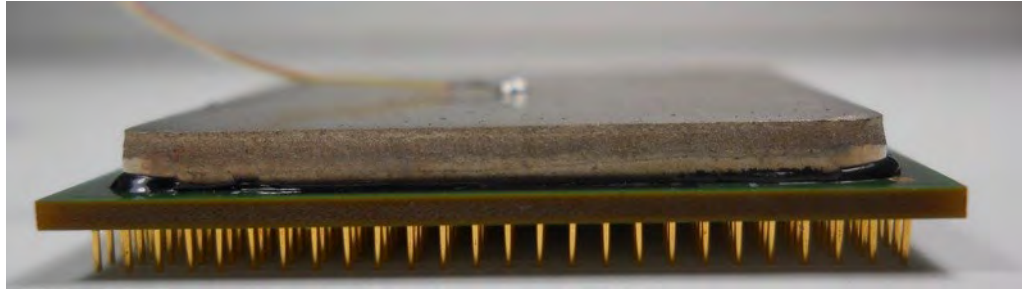
~80W applied (used for Θ_{jc} calculations)

Liquid cooling solution

TIM1 joint temperature: ~40°-50°C

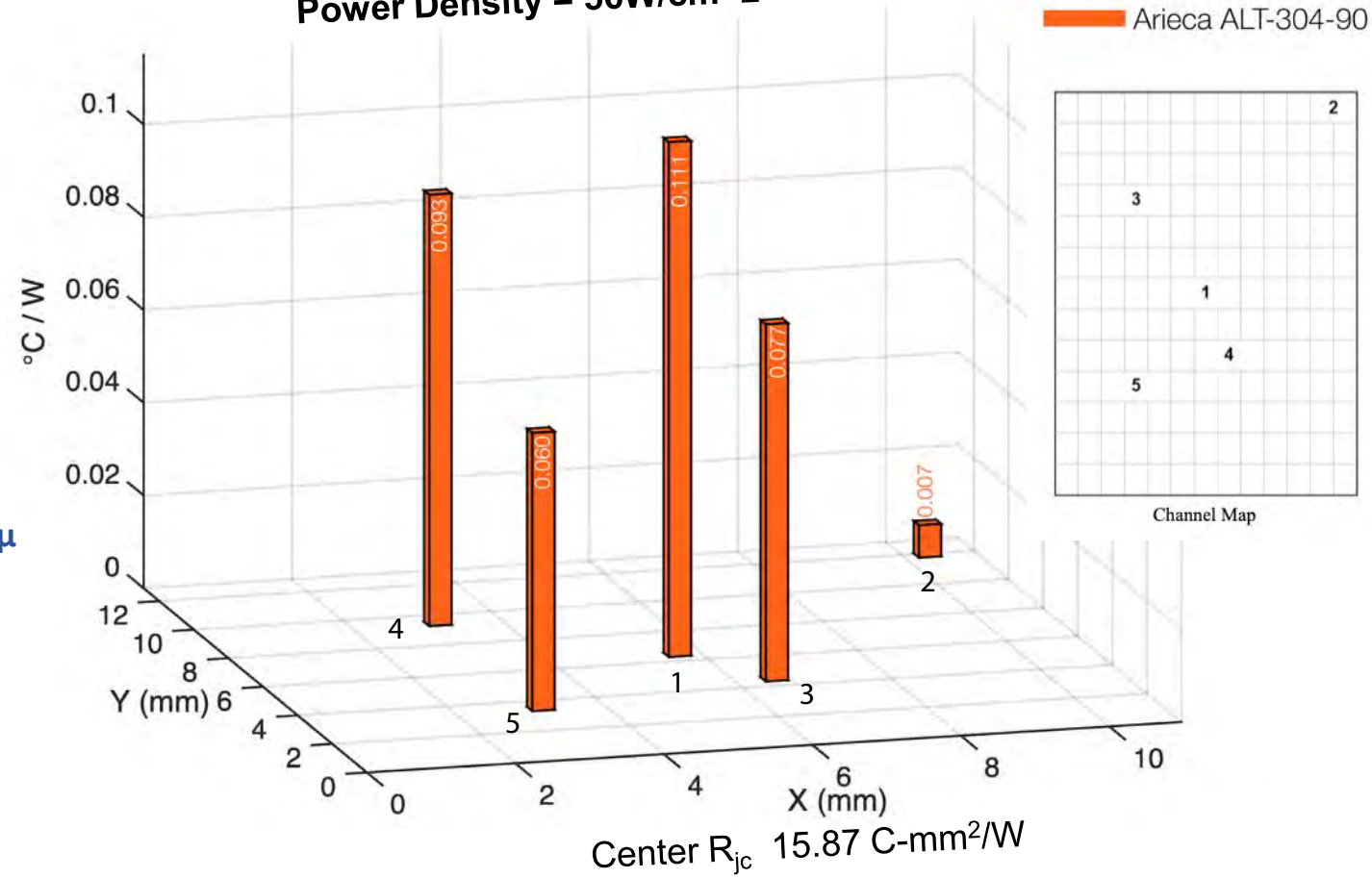
T₀ Thermal Results – TTV

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Die dimensions: 11mm x 13mm

Power Density = 56W/cm²



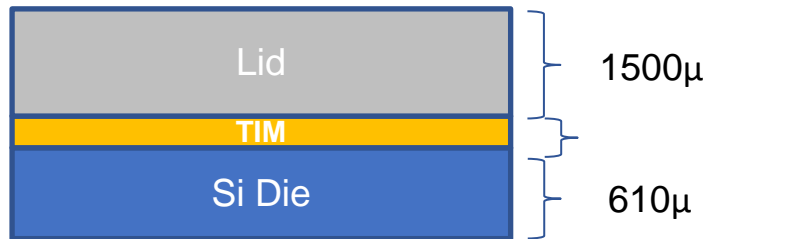
Thermal Resistance
junction to case
(C*mm²/W)

15.87

3.72

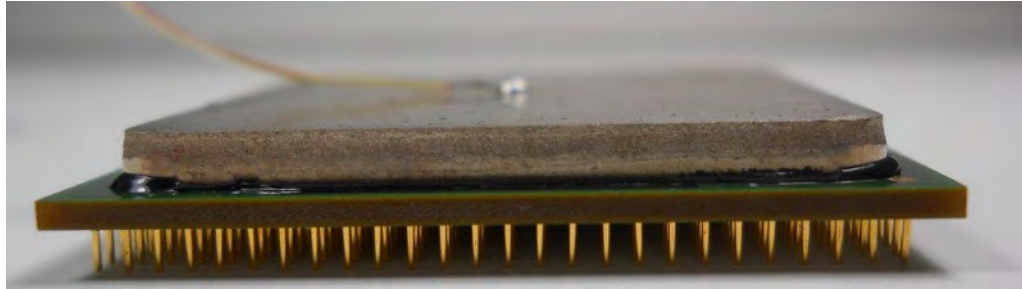
6.86

5.29



T₀ Thermal Results – TTV

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Die dimensions: 11mm x 13mm

Thermal Resistance junction to case

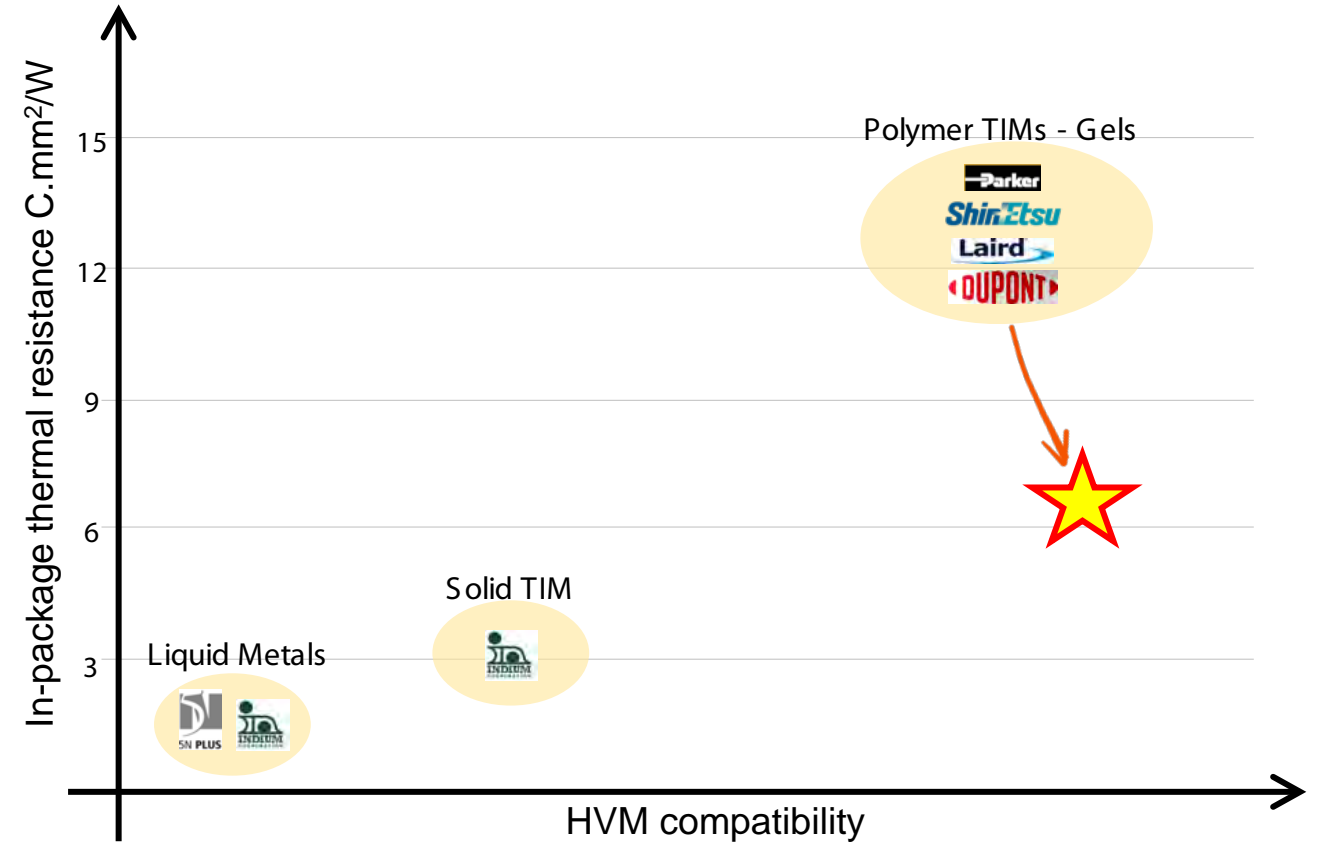
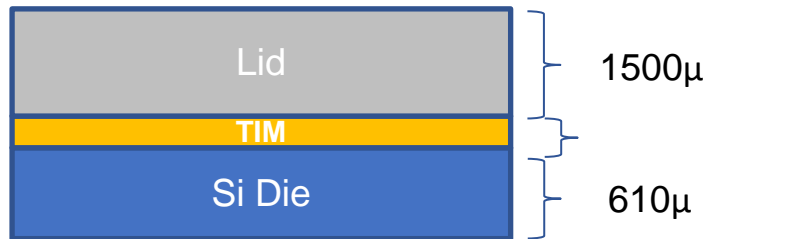
(C*mm²/W)

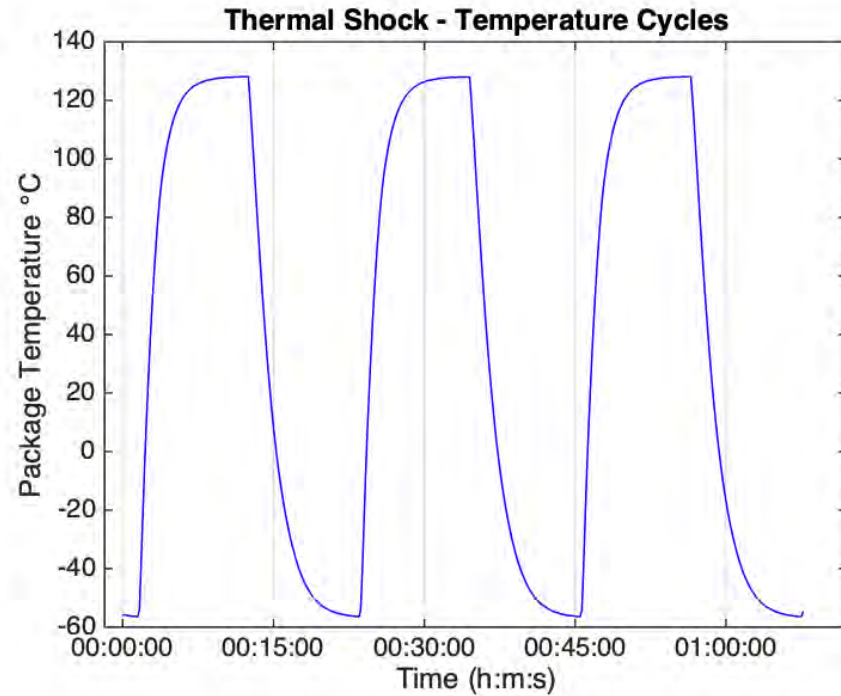
15.87

3.72

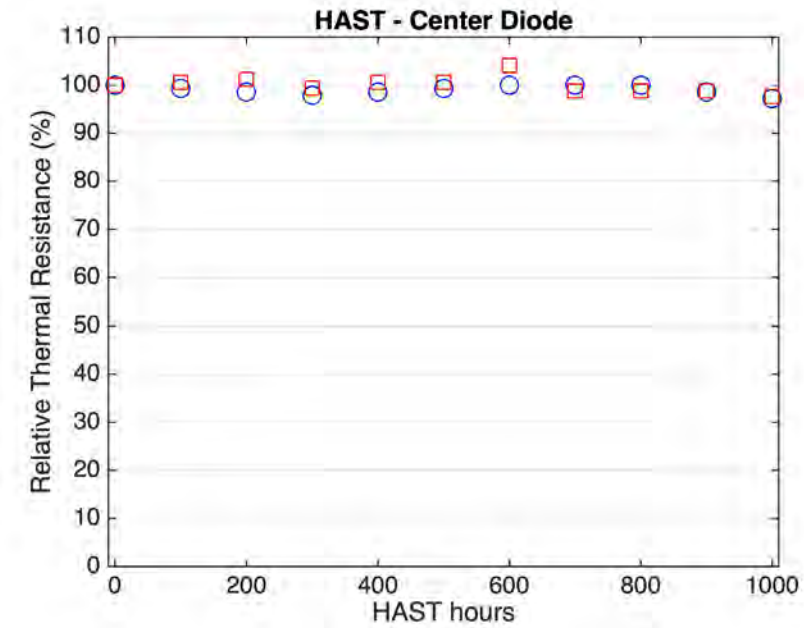
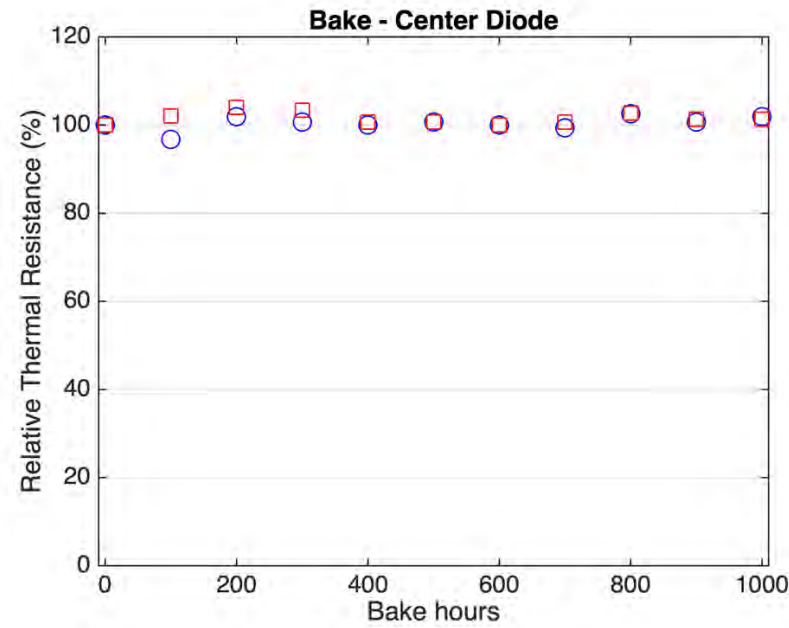
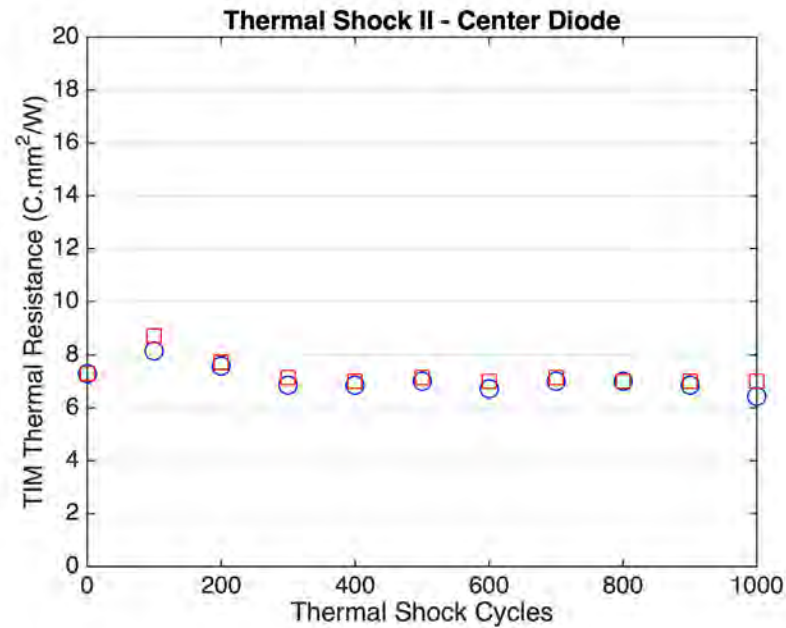
6.86

5.29





- MIL-STD-883B Compliant
- -55°C (-10°C, +0°C) to +125°C (+10°C, -0°C)
- T_0 thermal characterization
- Re-characterization following each batch of (100) thermal shock cycles



Thermal shock

per MIL-STD-883B:

Test area shall at -55°C (-10°C, +0°C) and +125°C (+10°C, -0°C) for a minimum of 10 minutes

High Temperature Storage

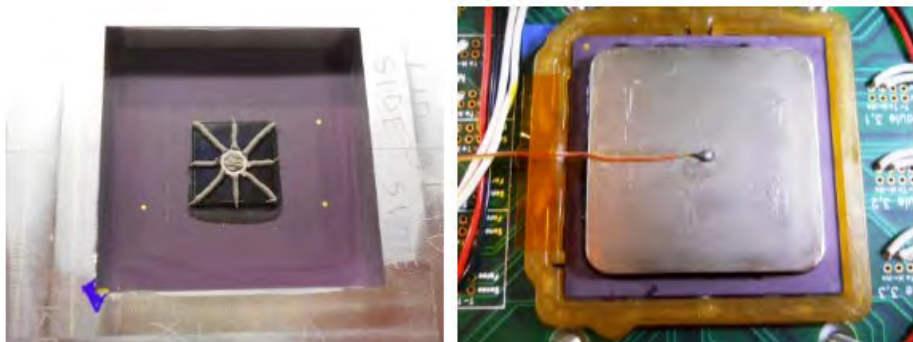
per JEDEC 22-A103 Condition A: +125°C (-0°C, +10°C).

HAST (85/85)

per JEDEC 22-A101: 85 ±2°C, 85 ±5%RH



Passes 5x Reflow Test

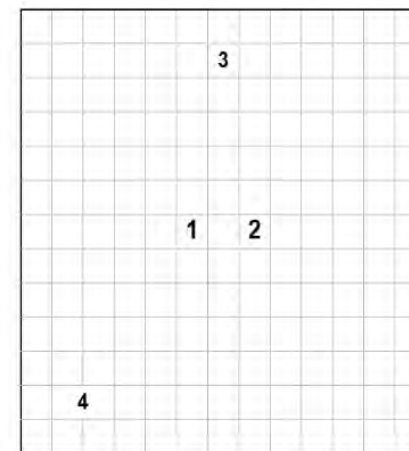
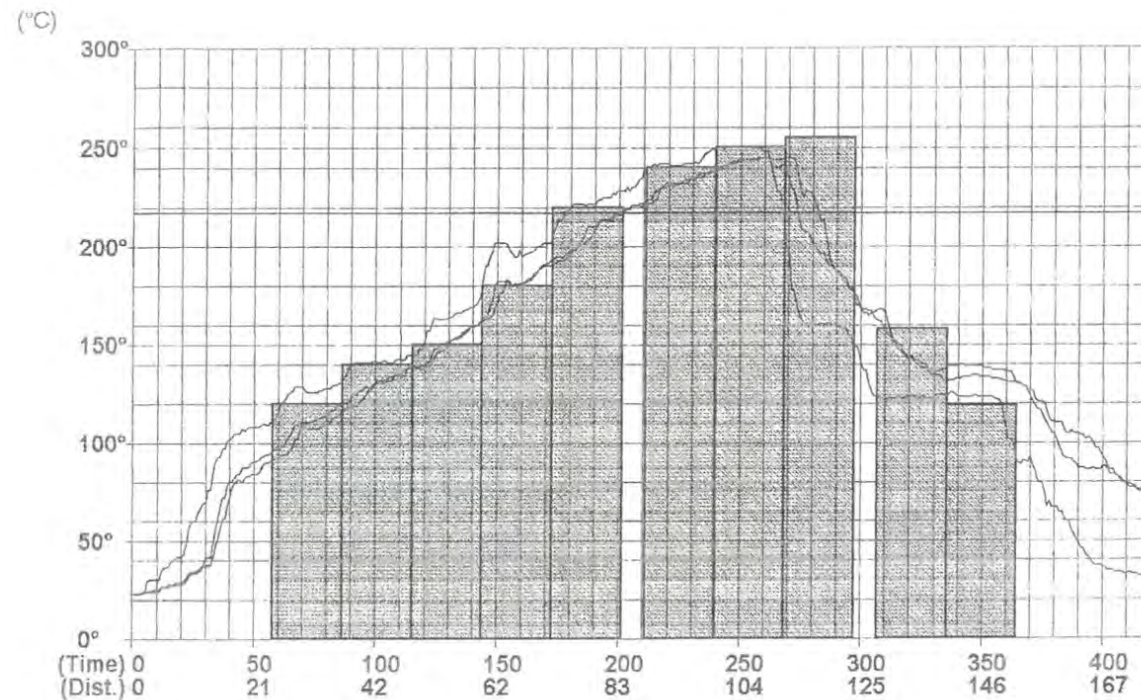


Precon sequence: 125°C bake (24hrs), transferred (within 30min.) to 60°C/60%RH (40hrs), transferred (within 2hrs) to outsourced MSL3 reflow (5X reflows, 5min. cool down between runs)

Preconditioning Θ_{jc} Results

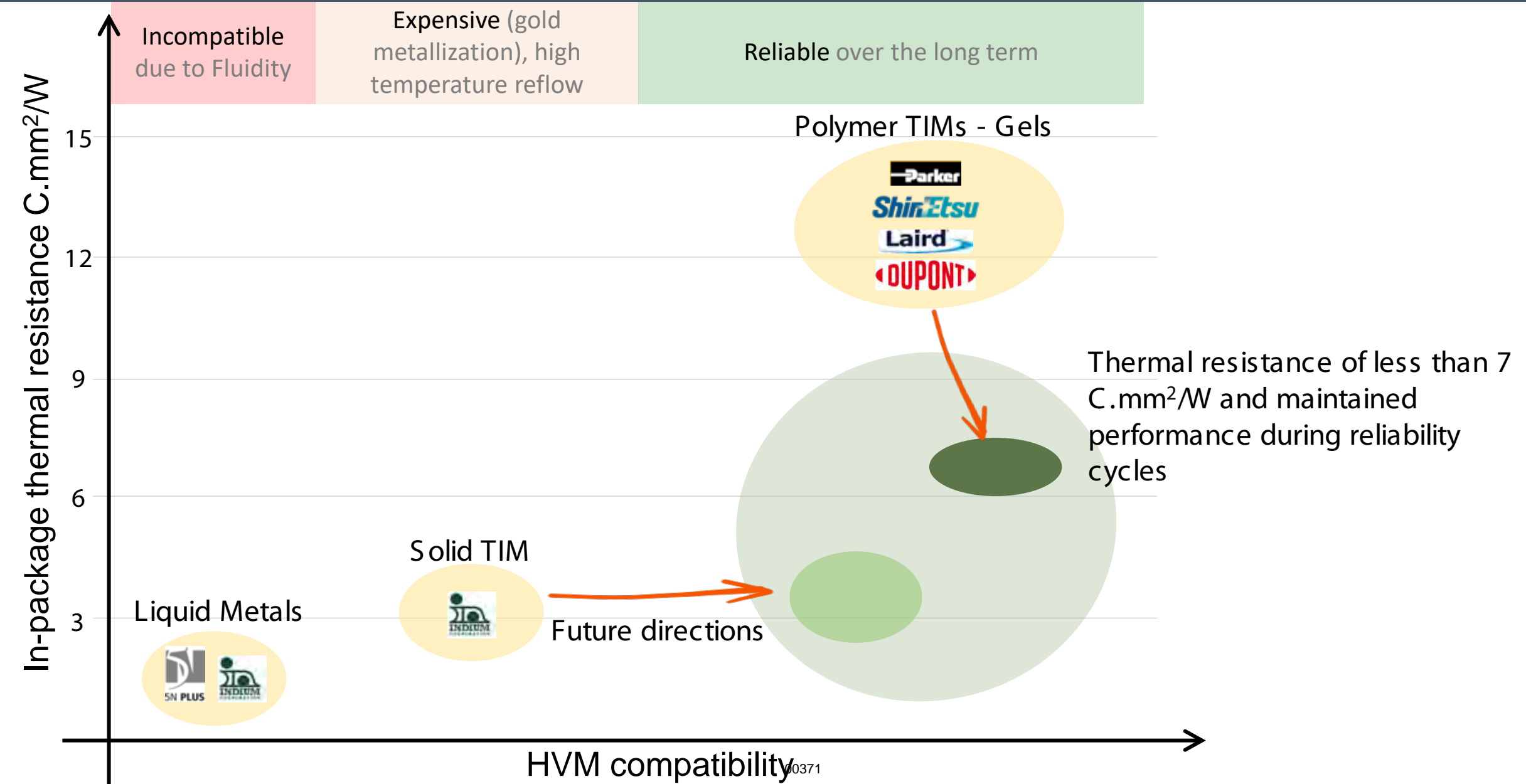
Channel #	Time Θ	Post-Precon
1	0.096	0.087
2	0.093	0.084
3	0.069	0.060
4	0.047	0.038
5	N/A	N/A
Ave. Θ_{jc}	0.076	0.067

00370



TTV Channel Map

Existing Solutions - Thermal Interface Materials (TIM1)





Next generation TIM performance

- Thermal performance rivaling Solid-TIMs (R_{jc} 3-5 C.mm²/W)
- Polymer-TIM HVM compatibility (liquid dispensed)

Liquid Metal Microstructure Development

- Morphology and Polydispersity
- Volume Loading

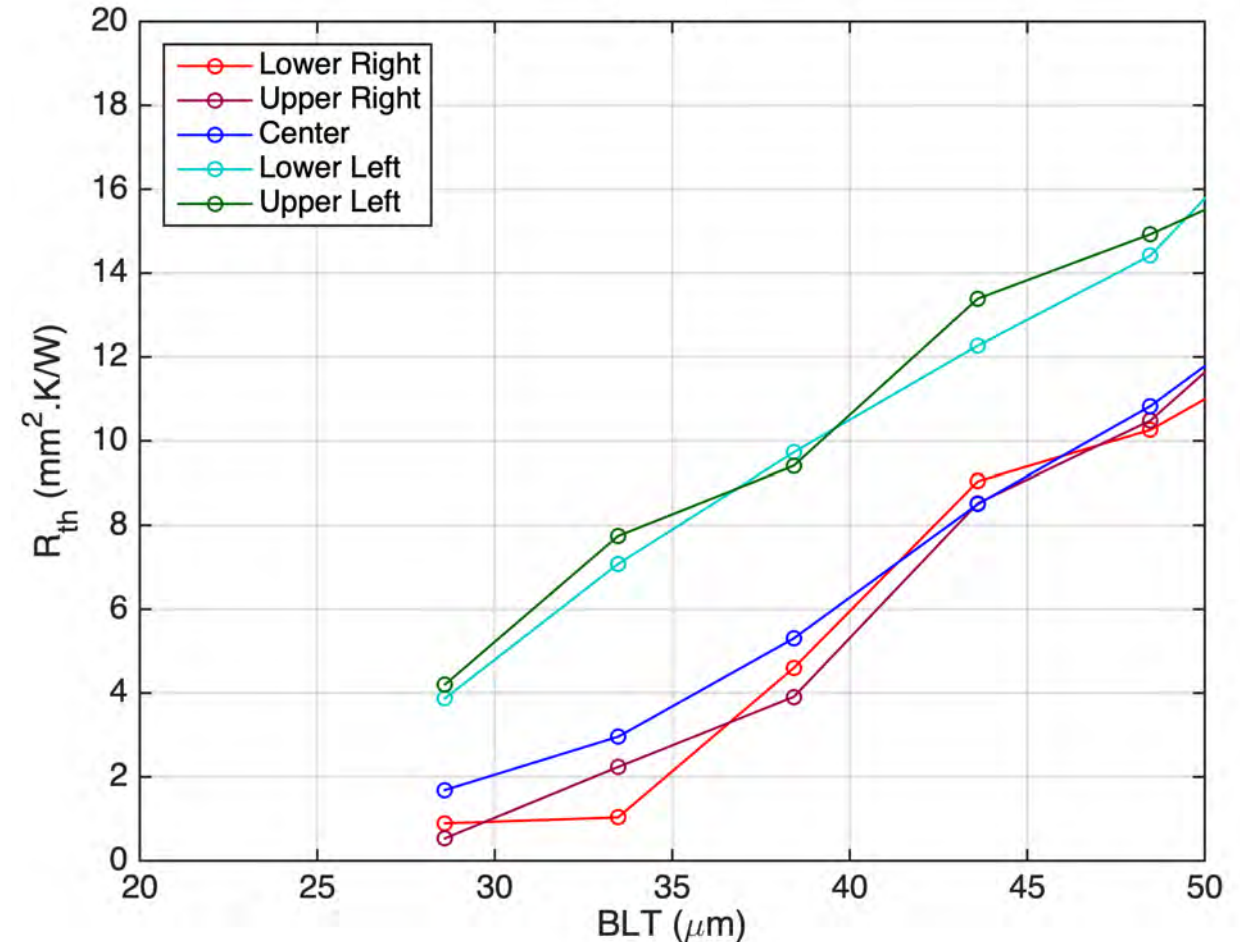
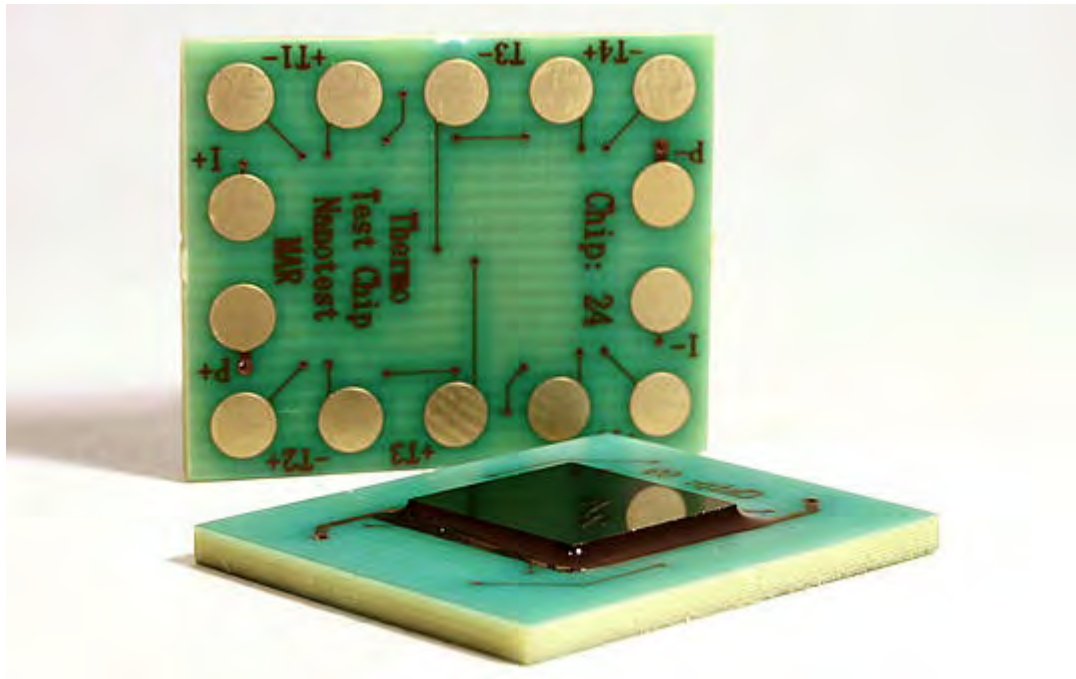
Polymer Development

- Rheology optimization
- Adhesion formulation

Packaging Process Development

- BLT optimization
- Cure kinetics

- Utilizing an ASTM-D5470 Test Setup
- Thermal resistance between Si and Ni interfaces measured, at 5 diodes located on the test chip





ARIECCA

Thank You!

Feel free to reach out to me at navid@ariecca.com

Low Temperature Performance - DSC

Super Cooling: The ability of liquids to go below melting temperature without becoming solid

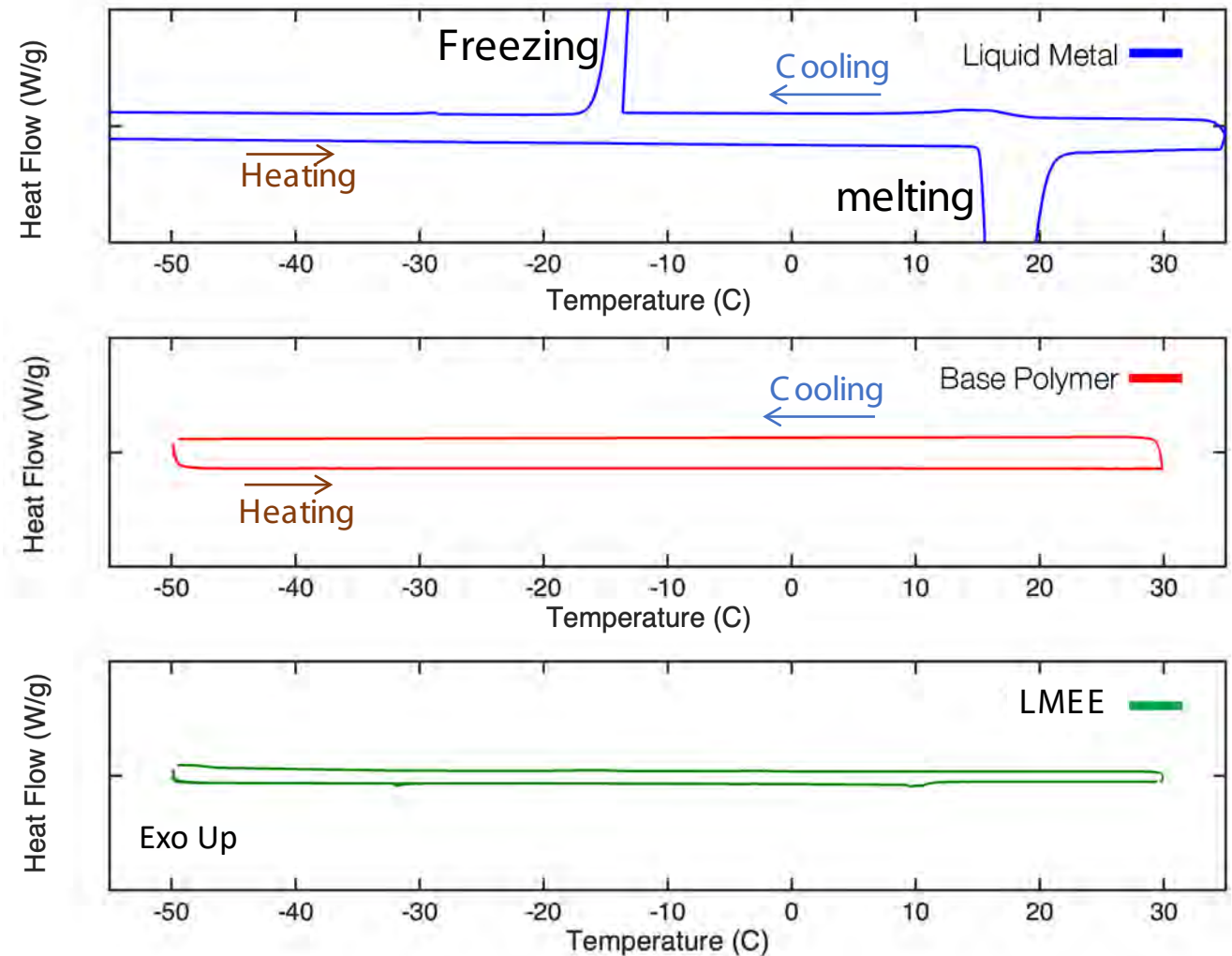
Size Effects

Droplets with 50 μ m radius

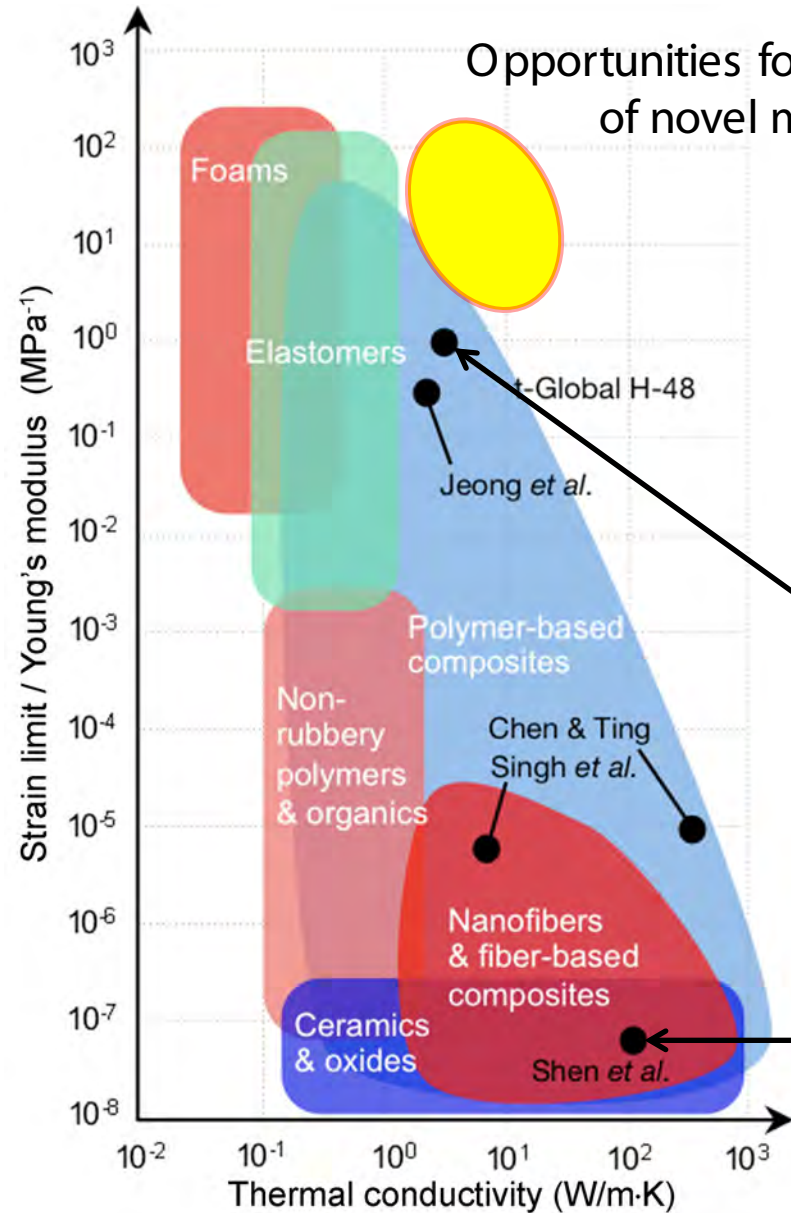
Metal	T_m (°C)	ΔT_s (°C)	$\Delta T_s / T_m$
Mercury	-40	58	0.247
Gallium	30	76	0.250
Tin	232	105	0.208
Bismuth	270	90	0.166

D. Turnbull, J. Appl. Phys., 1950

M. H. Malakooti *et al.*, "Liquid Metal Supercooling for Low-Temperature Thermoelectric Wearables," *Adv. Funct. Mater.*, vol. 29, no. 45, 2019.



Motivation – Thermo-Mechanical Tradeoff



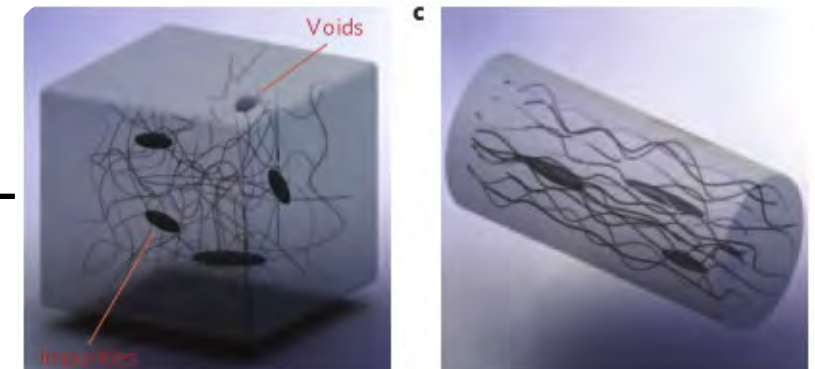
$$k_{solids} = \frac{1}{3} \int C(\omega) v(\omega) l(\omega) d\omega$$

Newton-Laplace equation

$$v(\omega) \approx V_{sound} \approx \sqrt{E/\rho}$$



Shen et al, *Nature Nano* (2010)



TIMbber™: The World's Most Adaptable TIM

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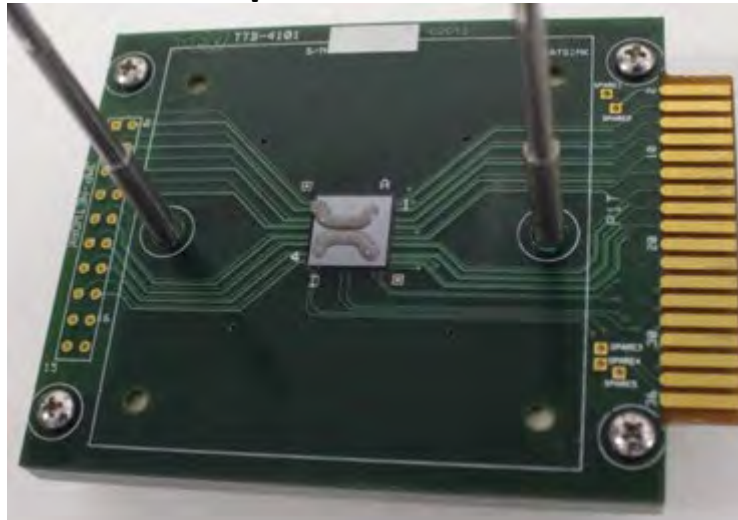


- **TIMbber™** is a spring-like thermal interface material
- Eliminates the trade-off between thermal performance and reliability imposed by current TIM solutions, allowing designers to push power limits

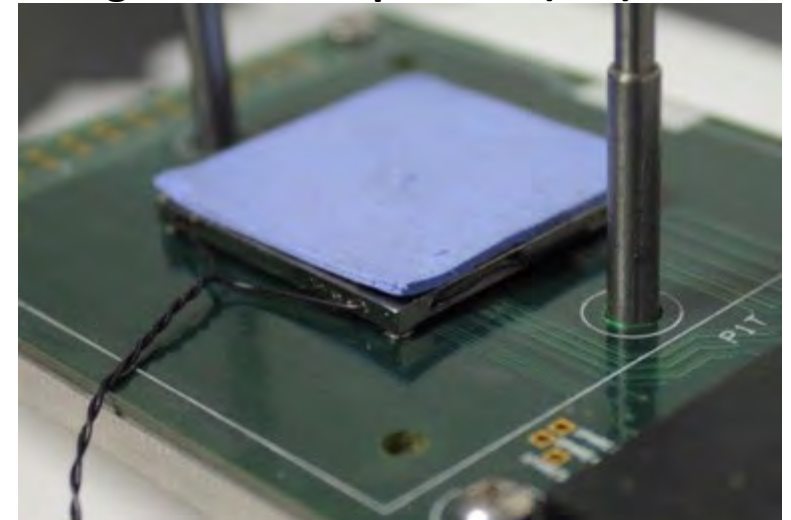
TIM being applied to IC with standard techniques



Completed TIM trace



Integrated Heat Spreader (IHS) added



Thermal Resistance Measurement

» Temperatures

- › Sample $T_{S,avg} \approx 25\text{ °C}$
- › Heater $T_H = 30\text{ °C}$ (set point)
- › Liquid Cold Plate $T_C \approx 15\text{ °C}$

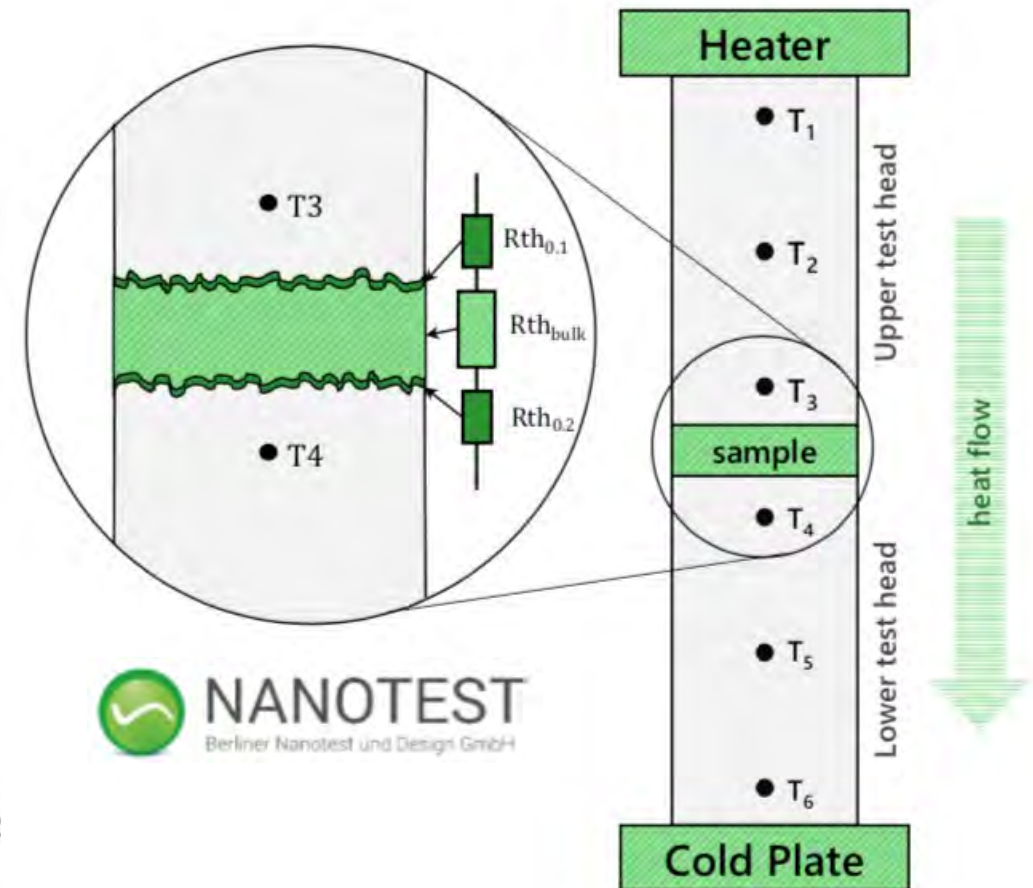
» BLTs

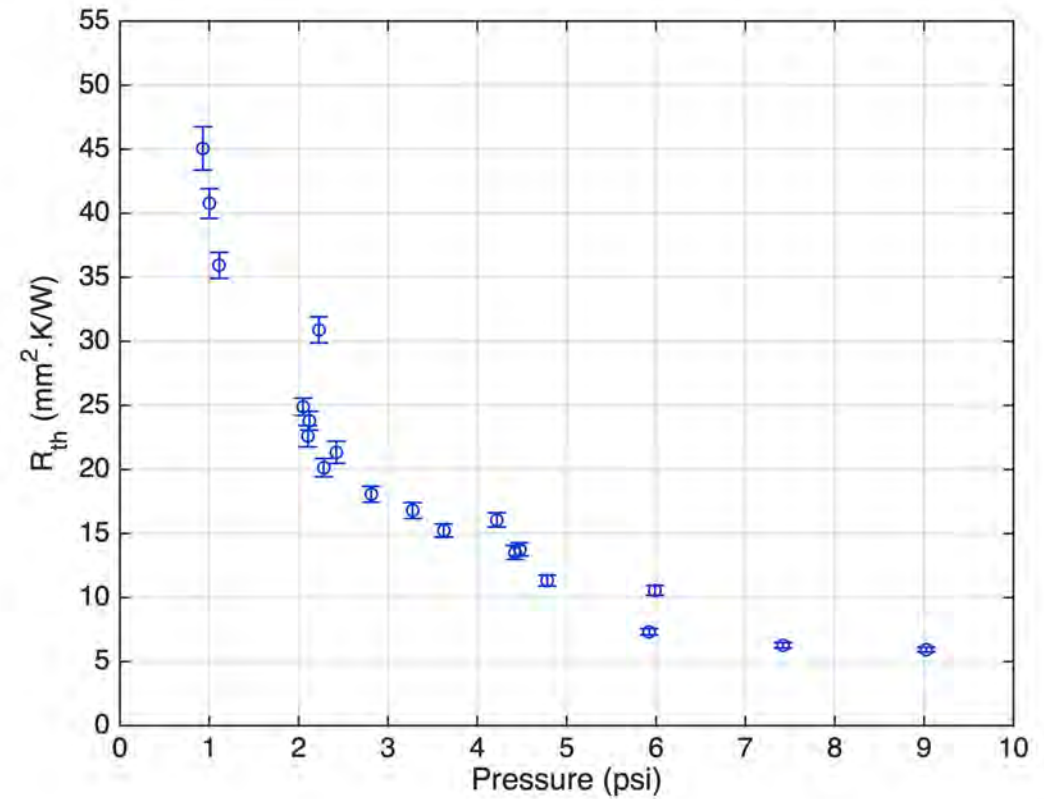
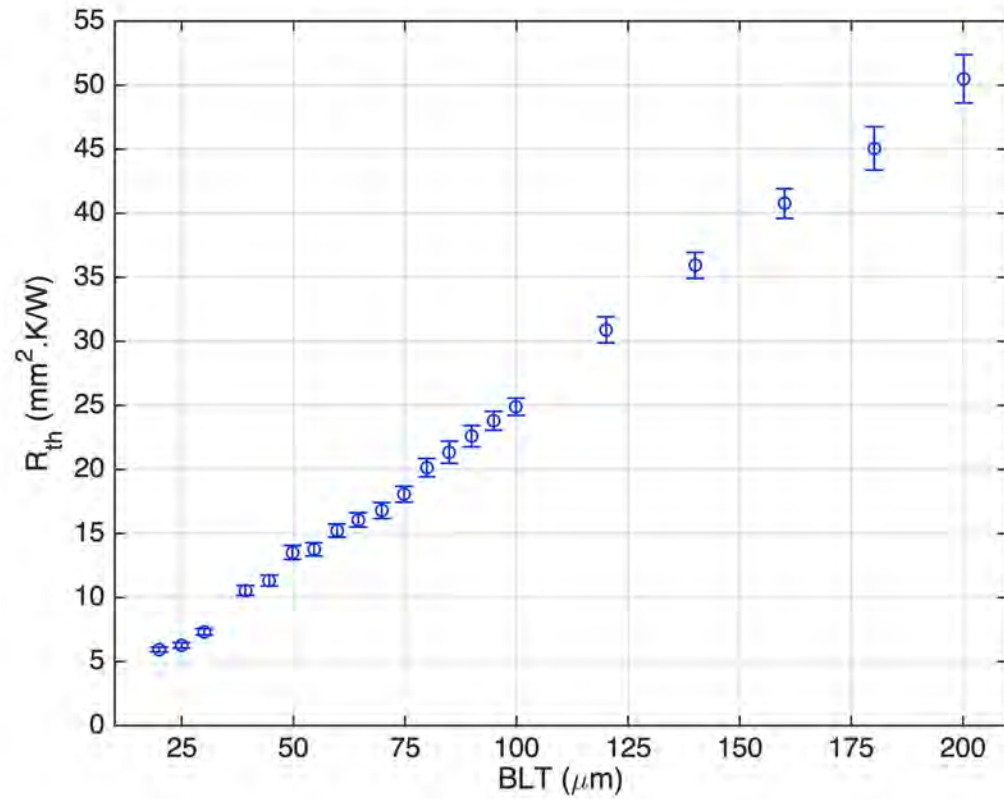
- › BLTs measured:
200, 180, ..., 120, 100,
95, 80, ..., 25, 20 μm

» Contacting surfaces

- › Material: Cu - Cu
- › Roughness $R_z < 2\text{ }\mu\text{m}$
- › Area A : 1.33 cm^2

» Measurement method: ASTM D 5470





BLT (μm)	R (mm ² .K/W)	P (psi)
20	5.9	9
30	7.3	5.9
40	10.3	4.4